

2.8-W/Ch Stereo Class-D Audio Amplifier with Dynamic Range Compression and AGC

FEATURES

- Filter-Free Class-D Architecture
- 1.7 W/Ch Into 8 Ω at 5 V (10% THD+N)
- 750 mW/Ch Into 8 Ω at 3.6 V (10% THD+N)
- 2.8 W/Ch Into 4 Ω at 5 V (10% THD+N)
- 1.5 W/Ch Into 4 Ω at 3.6 V (10% THD+N)
- Power Supply Range: 2.5 V to 5.5 V
- Flexible Operation With/Without I²C
- Programmable DRC/AGC Parameters
- Digital I²C Volume Control
- Selectable Gain from –28 dB to 30 dB in 1-dB Steps (when compression is used)
- Selectable Attack, Release and Hold Times
- 4 Selectable Compression Ratios
- Low Supply Current: 3.5 mA
- Low Shutdown Current: 0.2 μ A
- High PSRR: 80 dB
- Fast Start-up Time: 5 ms
- AGC Enable/Disable Function
- Limiter Enable/Disable Function
- Short-Circuit and Thermal Protection
- Space-Saving Package
 - 2.2 mm $\times$ 2.2 mm Nano-Free™ WCSP (YZH)

APPLICATIONS

- Wireless or Cellular Handsets and PDAs
- Portable Navigation Devices
- Portable DVD Player
- Notebook PCs
- Portable Radio
- Portable Games
- Educational Toys
- USB Speakers

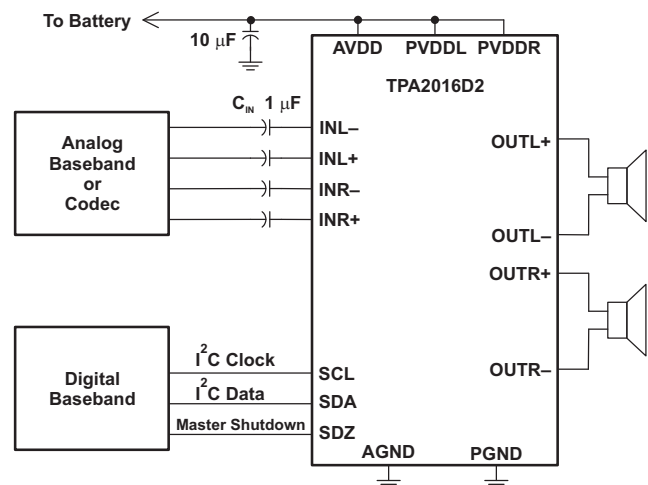
DESCRIPTION

The TPA2016D2 is a stereo, filter-free Class-D audio power amplifier with volume control, dynamic range compression (DRC) and automatic gain control (AGC). It is available in a 2.2 mm $\times$ 2.2 mm WCSP package and 20-pin QFN package.

The DRC/AGC function in the TPA2016D2 is programmable via a digital I²C interface. The DRC/AGC function can be configured to automatically prevent distortion of the audio signal and enhance quiet passages that are normally not heard. The DRC/AGC can also be configured to protect the speaker from damage at high power levels and compress the dynamic range of music to fit within the dynamic range of the speaker. The gain can be selected from –28 dB to +30 dB in 1-dB steps. The TPA2016D2 is capable of driving 1.7 W/Ch at 5 V or 750 mW/Ch at 3.6 V into 8 Ω load or 2.8 W/Ch at 5 V or 1.5 W/Ch at 3.6 V into 4 Ω load. The device features independent software shutdown controls for each channel and also provides thermal and short circuit protection.

In addition to these features, a fast start-up time and small package size make the TPA2016D2 an ideal choice for cellular handsets, PDAs and other portable applications.

SIMPLIFIED APPLICATION DIAGRAM



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

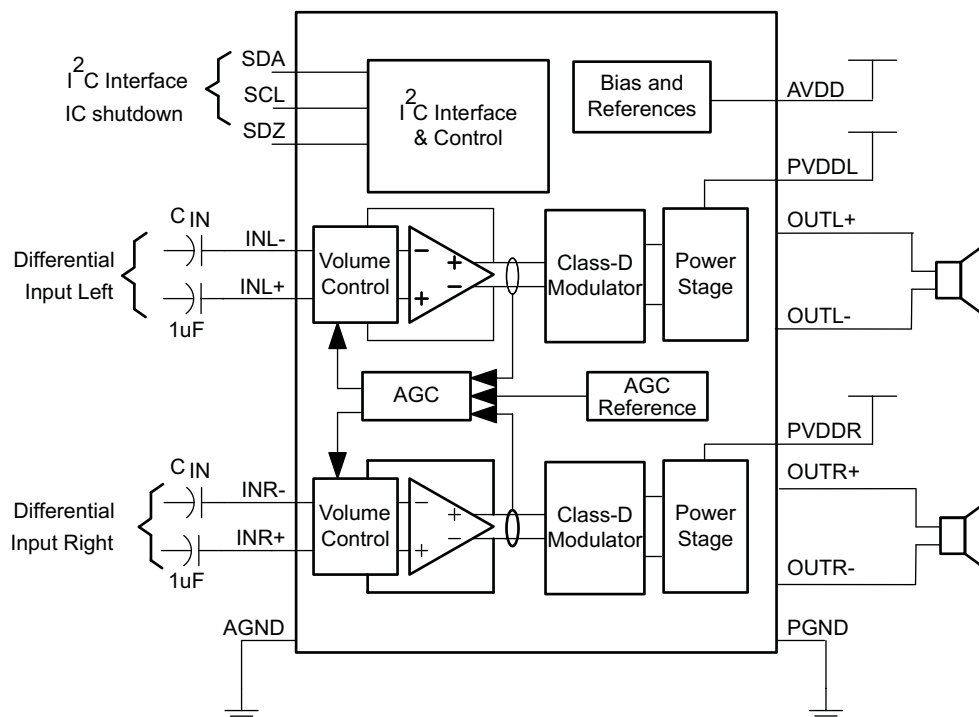
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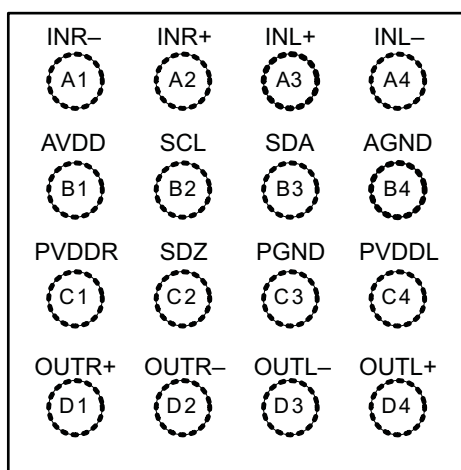
These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

FUNCTIONAL BLOCK DIAGRAM

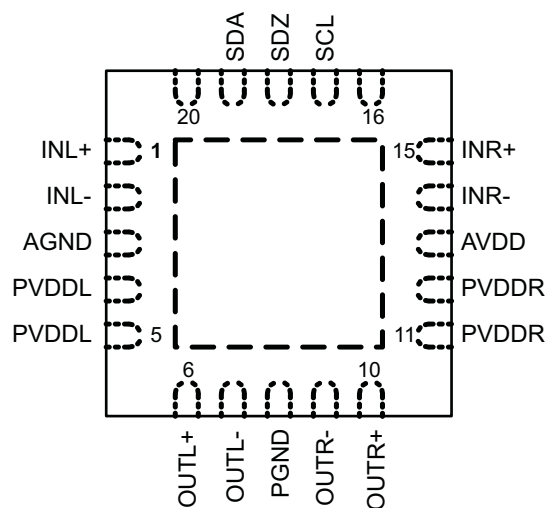


DEVICE PINOUT

**YZH (WCSP) PACKAGE
(Top View)**



**RTJ (QFN) PACKAGE
(Top View)**



PIN FUNCTIONS

PIN			I/O/P	DESCRIPTION
NAME	WCSP	RTJ		
INR+	A2	15	I	Right channel positive audio input
INR–	A1	14	I	Right channel negative audio input
INL+	A3	1	I	Left channel positive audio input
INL–	A4	2	I	Left channel negative audio input
SDZ	C2	18	I	Shutdown terminal (active low)
SDA	B3	19	I/O	I ² C data interface
SCL	B2	17	I	I ² C clock interface
OUTR+	D1	10	O	Right channel positive differential output
OUTR–	D2	9	O	Right channel negative differential output
OUTL+	D4	6	O	Left channel positive differential output
OUTL–	D3	7	O	Left channel negative differential output
AVDD	B1	13	P	Analog supply (must be the same as PVDDR and PVDDL)
AGND	B4	3	P	Analog ground (all GND pins need to be connected)
PVDDR	C1	11, 12	P	Right channel power supply (must be the same as AVDD and PVDDL)
PGND	C3	8	P	Power ground (all GND pins need to be connected)
PVDDL	C4	4, 5	P	Left channel power supply (must be the same as AVDD and PVDDR)
		16, 20		Not connected

ABSOLUTE MAXIMUM RATINGS⁽¹⁾

over operating free-air temperature range (unless otherwise noted).

			VALUE / UNIT
V _{DD}	Supply voltage	AVDD, PVDDR, PVDDL	–0.3 V to 6 V
	Input voltage	SDZ, INR+, INR–, INL+, INL–	–0.3 V to V _{DD} +0.3 V
		SDA, SCL	–0.3 V to 6 V
	Continuous total power dissipation		See Dissipation Ratings Table
T _A	Operating free-air temperature range		–40°C to +85°C
T _J	Operating junction temperature range		–40°C to 150°C
T _{stg}	Storage temperature range		–65°C to 150°C
ESD	Electro-Static Discharge Tolerance, all pins	Human Body Model (HBM)	2 KV
		Charged Device Model (CDM)	500 V
R _{LOAD}	Minimum load resistance		3.2 Ω

- (1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

DISSIPATION RATINGS TABLE⁽¹⁾

PACKAGE	T _A ≤ 25°C	DERATING FACTOR	T _A = 70°C	T _A = 85°C
16-ball WCSP	1.25 W	10 mW/°C	0.8 W	0.65 W
20-pin QFN	5.2 W	41.6 mW/°C	3.12 W	2.7 W

- (1) Dissipations ratings are for a 2-side, 2-plane PCB.

AVAILABLE OPTIONS⁽¹⁾

T _A	PACKAGED DEVICES ⁽²⁾	PART NUMBER	SYMBOL
–40°C to 85°C	16-ball, 2,2 mm × 2,2 mm WCSP (+0.01 mm/ –0.09 mm tolerance)	TPA2016D2YZHR	CCJ
		TPA2016D2YZHT	CCJ
–40°C to 85°C	20-pin, 4 mm × 4 mm QFN (RTJ)	TPA2016D2RTJR	–
		TPA2016D2RTJT	–

- (1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI Web site at www.ti.com
- (2) The YZH packages are only available taped and reeled. The suffix R indicates a reel of 3000; the suffix T indicates a reel of 250.

RECOMMENDED OPERATING CONDITIONS

			MIN	MAX	UNIT
V _{DD}	Supply voltage	AVDD, PVDDR, PVDDL	2.5	5.5	V
V _{IH}	High-level input voltage	SDZ, SDA, SCL	1.3		V
V _{IL}	Low-level input voltage	SDZ, SDA, SCL		0.6	V
T _A	Operating free-air temperature		−40	+85	°C

ELECTRICAL CHARACTERISTICS

at T_A = 25°C, V_{DD} = 3.6 V, SDZ = 1.3 V, and R_L = 8 Ω + 33 μH (unless otherwise noted).

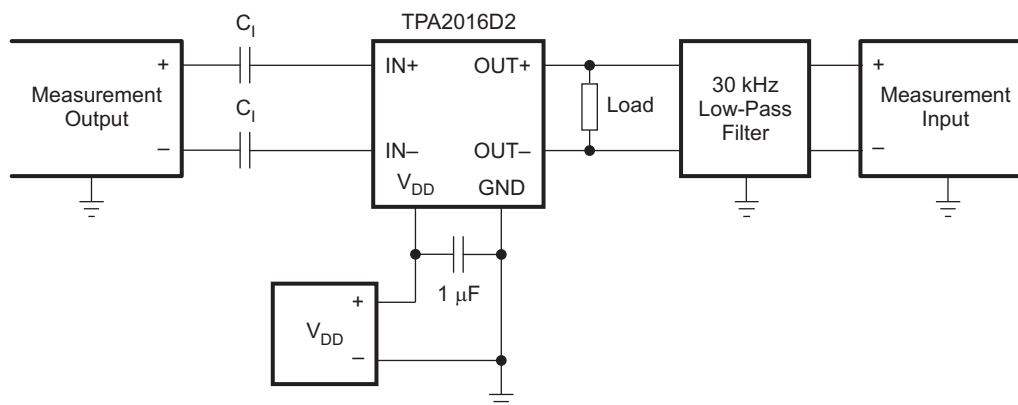
PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
V _{DD}	Supply voltage range		2.5	3.6	5.5	V
I _{SDZ}	Shutdown quiescent current	SDZ = 0.35 V, V _{DD} = 2.5 V		0.1	1	μA
		SDZ = 0.35 V, V _{DD} = 3.6 V		0.2	1	
		SDZ = 0.35 V, V _{DD} = 5.5 V		0.3	1	
I _{SWS}	Software shutdown quiescent current	SDZ = 1.3 V, V _{DD} = 2.5 V		35	50	μA
		SDZ = 1.3 V, V _{DD} = 3.6 V		50	70	
		SDZ = 1.3 V, V _{DD} = 5.5 V		75	110	
I _{DD}	Supply current	V _{DD} = 2.5 V		3.5	4.5	mA
		V _{DD} = 3.6 V		3.7	4.7	
		V _{DD} = 5.5 V		4.5	5.5	
f _{SW}	Class D Switching Frequency		275	300	325	kHz
I _{IH}	High-level input current	V _{DD} = 5.5 V, SDZ = 5.8 V			1	μA
I _{IL}	Low-level input current	V _{DD} = 5.5 V, SDZ = −0.3 V	−1			μA
t _{START}	Start-up time	2.5 V ≤ V _{DD} ≤ 5.5 V no pop, C _{IN} ≤ 1 μF		5		ms
POR	Power on reset ON threshold			2	2.3	V
POR	Power on reset hysteresis			0.2		V
CMRR	Input common mode rejection	R _L = 8 Ω, V _{icm} = 0.5 V and V _{icm} = V _{DD} − 0.8 V, differential inputs shorted		−70		dB
V _{oo}	Output offset voltage	V _{DD} = 3.6 V, A _V = 6 dB, R _L = 8 Ω, inputs ac grounded	−10	2	10	mV
Z _{OUT}	Output Impedance in shutdown mode	SDZ = 0.35 V		2		kΩ
	Gain accuracy	Compression and limiter disabled, Gain = 0 to 30 dB	−0.5		0.5	dB
PSRR	Power supply rejection ratio	V _{DD} = 2.5 V to 4.7 V		−80		dB

OPERATING CHARACTERISTICS

at $T_A = 25^\circ\text{C}$, $V_{DD} = 3.6\text{V}$, $SDZ = 1.3\text{ V}$, $R_L = 8\ \Omega + 33\ \mu\text{H}$, and $A_v = 6\text{ dB}$ (unless otherwise noted).

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
k_{SVR} power-supply ripple rejection ratio	$V_{DD} = 3.6\text{ Vdc}$ with ac of 200 mV_{PP} at 217 Hz		–68		dB
THD+N Total harmonic distortion + noise	$f_{aud_in} = 1\text{ kHz}$; $P_O = 550\text{ mW}$; $V_{DD} = 3.6\text{ V}$		0.1%		
	$f_{aud_in} = 1\text{ kHz}$; $P_O = 1\text{ W}$; $V_{DD} = 5\text{ V}$		0.1%		
	$f_{aud_in} = 1\text{ kHz}$; $P_O = 630\text{ mW}$; $V_{DD} = 3.6\text{ V}$		1%		
	$f_{aud_in} = 1\text{ kHz}$; $P_O = 1.4\text{ W}$; $V_{DD} = 5\text{ V}$		1%		
$N_{f_{nF}}$ Output integrated noise	$A_v = 6\text{ dB}$		44		μV
N_{f_A} Output integrated noise	$A_v = 6\text{ dB}$ floor, A-weighted		33		μV
FR Frequency response	$A_v = 6\text{ dB}$	20		20000	Hz
$P_{O_{max}}$ Maximum output power	THD+N = 10%, $V_{DD} = 5\text{ V}$, $R_L = 8\ \Omega$		1.72		W
	THD+N = 10%, $V_{DD} = 3.6\text{ V}$, $R_L = 8\ \Omega$		750		mW
	THD+N = 10%, $V_{DD} = 5\text{ V}$, $R_L = 4\ \Omega$		2.8		W
	THD+N = 10%, $V_{DD} = 3.6\text{ V}$, $R_L = 4\ \Omega$		1.5		mW
η Efficiency	THD+N = 1%, $V_{DD} = 3.6\text{ V}$, $R_L = 8\ \Omega$, $P_O = 0.63\text{ W}$		90%		
	THD+N = 1%, $V_{DD} = 5\text{ V}$, $R_L = 8\ \Omega$, $P_O = 1.4\text{ W}$		90%		

TEST SET-UP FOR GRAPHS



- (1) All measurements were taken with a $1\text{-}\mu\text{F}$ C_1 (unless otherwise noted.)
- (2) A $33\text{-}\mu\text{H}$ inductor was placed in series with the load resistor to emulate a small speaker for efficiency measurements.
- (3) The 30-kHz low-pass filter is required, even if the analyzer has an internal low-pass filter. An RC low-pass filter ($1\text{ k}\Omega$ 4.7 nF) is used on each output for the data sheet graphs.
- (4) All THD + N graphs are taken with outputs out of phase (unless otherwise noted). All data is taken on left channel.
- (5) All data is taken on the WCSP package unless otherwise noted.

I²C TIMING CHARACTERISTICS

For I²C Interface Signals Over Recommended Operating Conditions (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
f_{SCL}	Frequency, SCL	No wait states			400	kHz
$t_{W(H)}$	Pulse duration, SCL high		0.6			μ s
$t_{W(L)}$	Pulse duration, SCL low		1.3			μ s
$t_{SU(1)}$	Setup time, SDA to SCL		100			ns
t_{H1}	Hold time, SCL to SDA		10			ns
$t_{(buf)}$	Bus free time between stop and start condition		1.3			μ s
t_{SU2}	Setup time, SCL to start condition		0.6			μ s
t_{H2}	Hold time, start condition to SCL		0.6			μ s
t_{SU3}	Setup time, SCL to stop condition		0.6			μ s

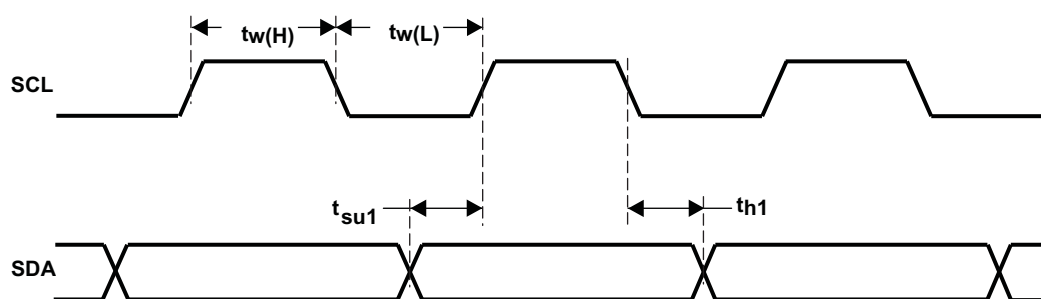


Figure 1. SCL and SDA Timing

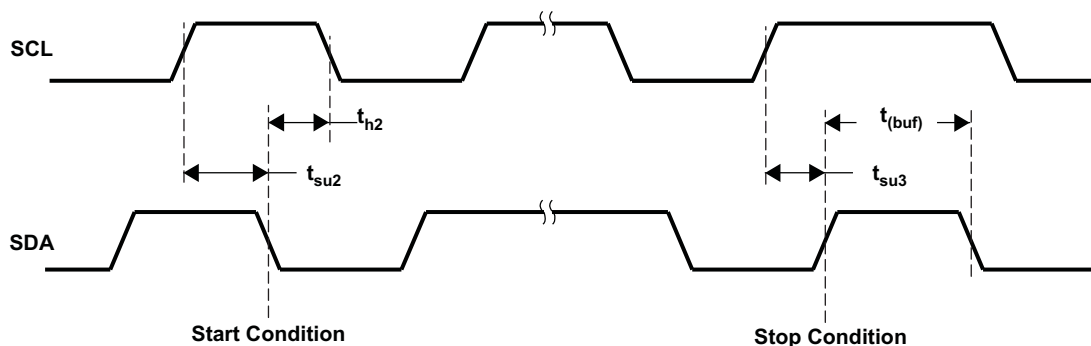


Figure 2. Start and Stop Conditions Timing

TYPICAL CHARACTERISTICS

with $C_{(DECOUPLE)} = 1 \mu\text{F}$, $C_I = 1 \mu\text{F}$.

**QUIESCENT SUPPLY CURRENT
VS
SUPPLY VOLTAGE**

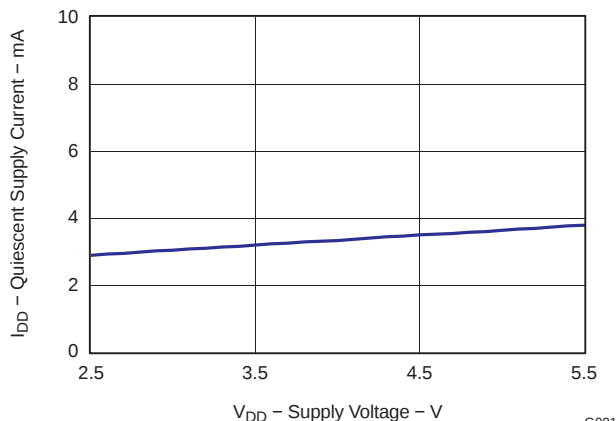


Figure 3.

**SUPPLY CURRENT
VS
SUPPLY VOLTAGE IN SHUTDOWN**

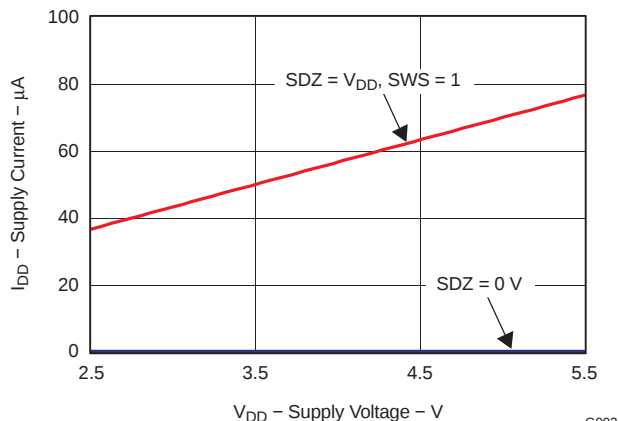


Figure 4.

**OUTPUT LEVEL
VS
INPUT LEVEL WITH LIMITER ENABLED**

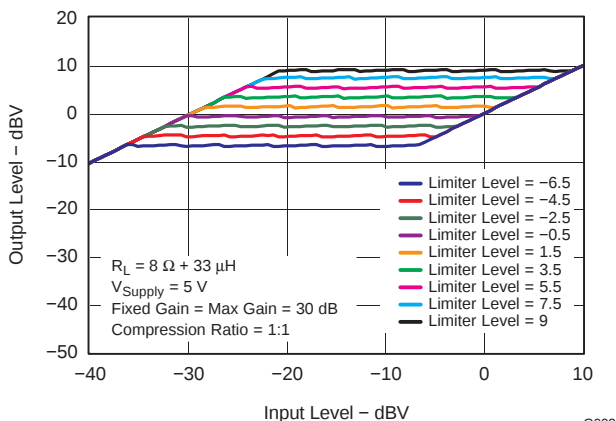


Figure 5.

**OUTPUT LEVEL
VS
INPUT LEVEL WITH 2:1 COMPRESSION**

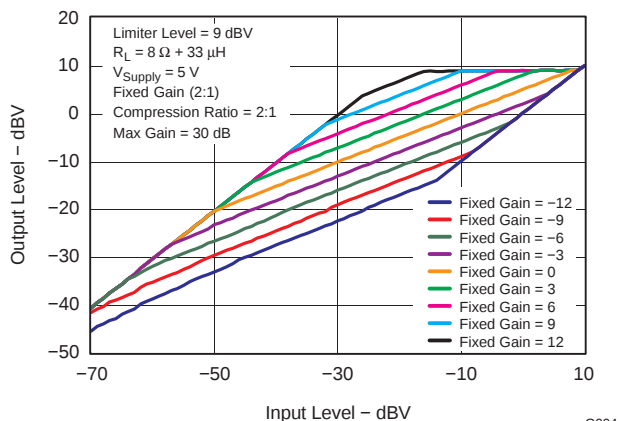


Figure 6.

**OUTPUT LEVEL
VS
INPUT LEVEL WITH 4:1 COMPRESSION**

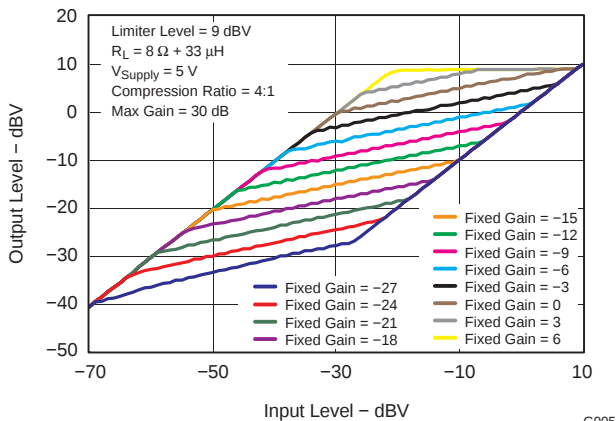


Figure 7.

**OUTPUT LEVEL
VS
INPUT LEVEL WITH 8:1 COMPRESSION**

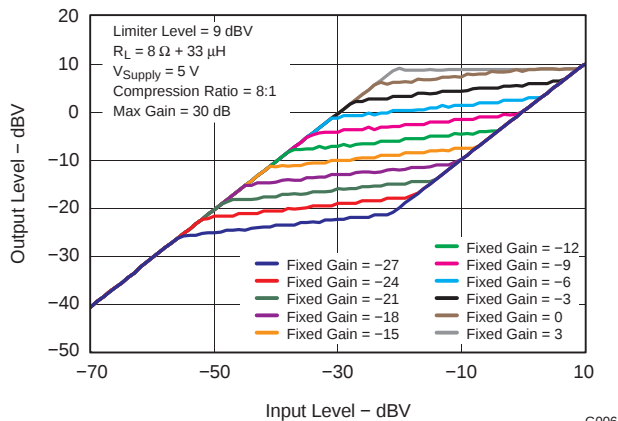


Figure 8.

TYPICAL CHARACTERISTICS (continued)

with $C_{(DECOUPLE)} = 1\ \mu\text{F}$, $C_1 = 1\ \mu\text{F}$.

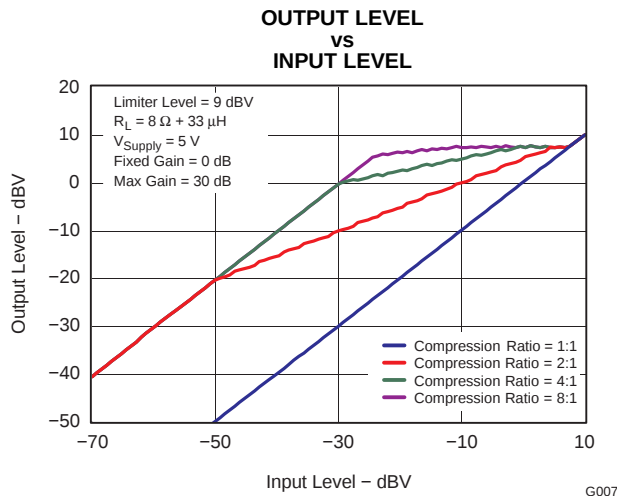


Figure 9.

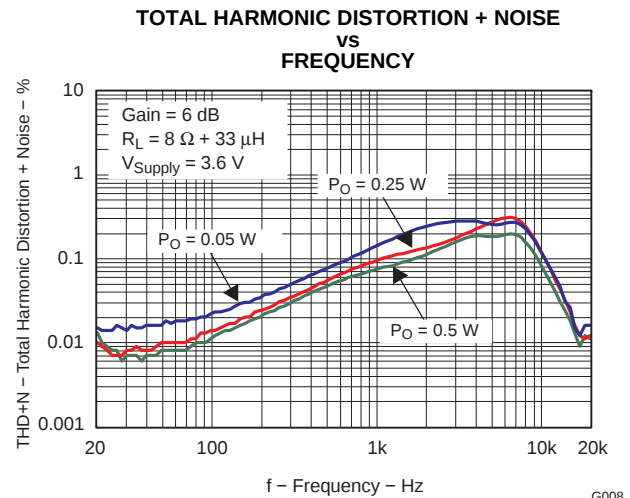


Figure 10.

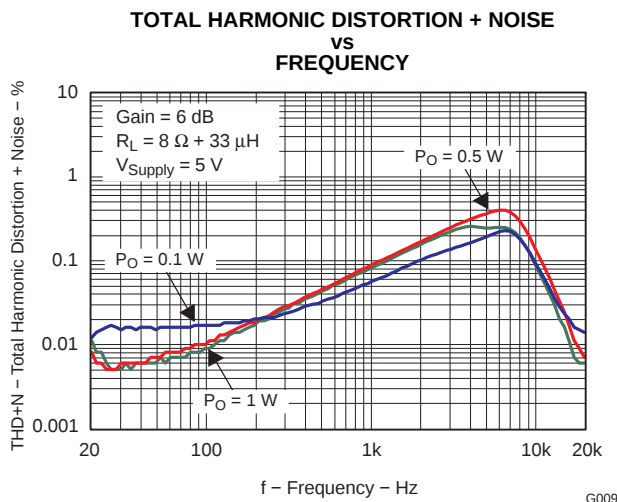


Figure 11.

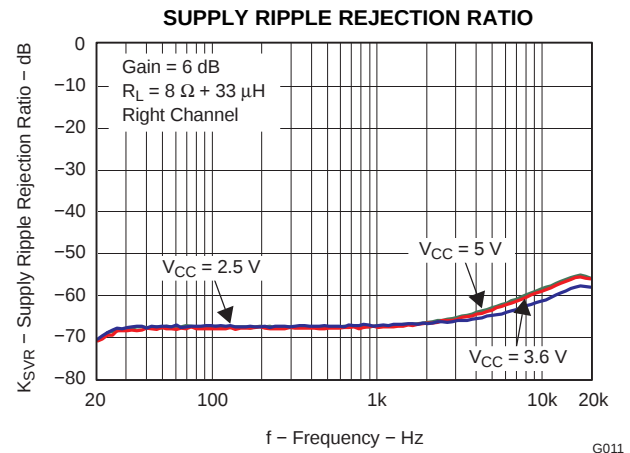


Figure 12.

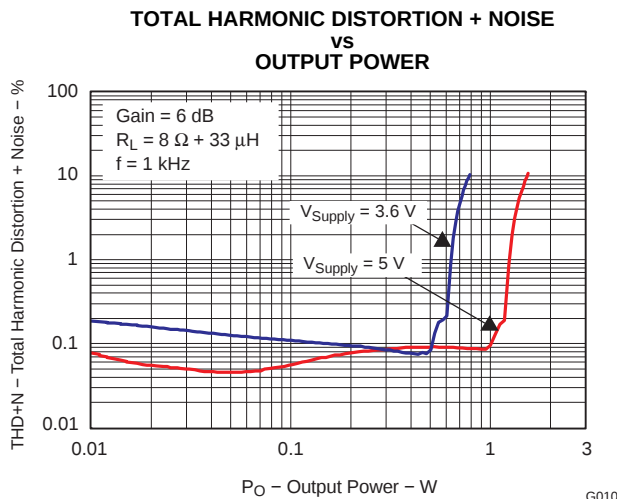


Figure 13.

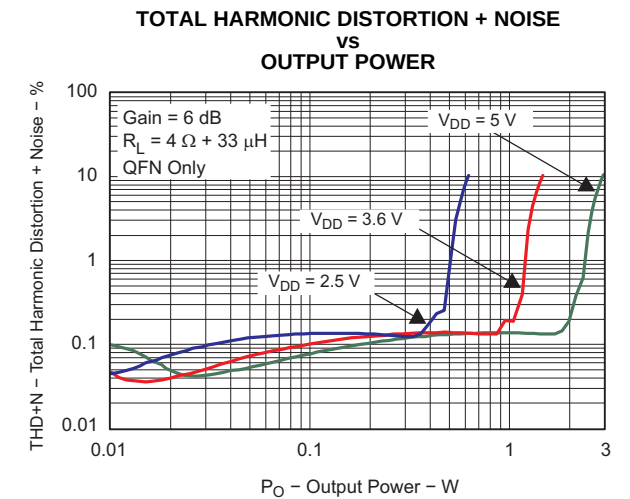


Figure 14.

TYPICAL CHARACTERISTICS (continued)

with $C_{(DECOUPLE)} = 1 \mu\text{F}$, $C_I = 1 \mu\text{F}$.

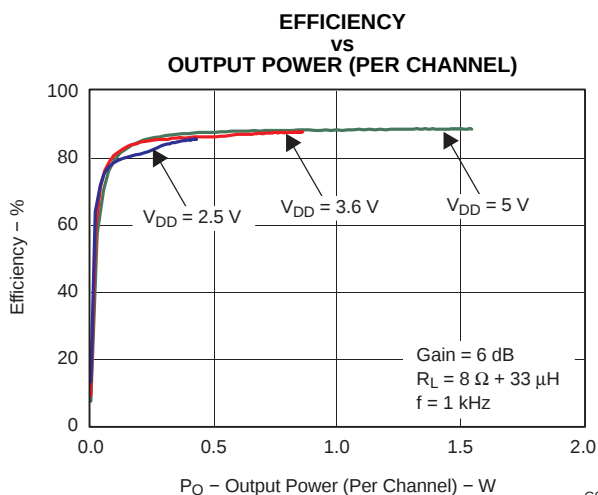


Figure 15.

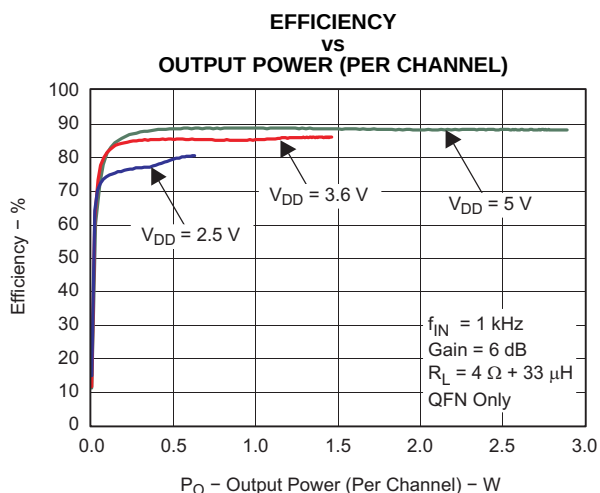


Figure 16.

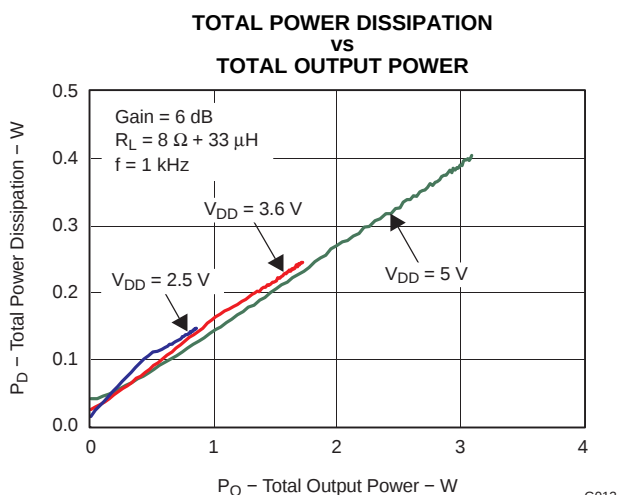


Figure 17.

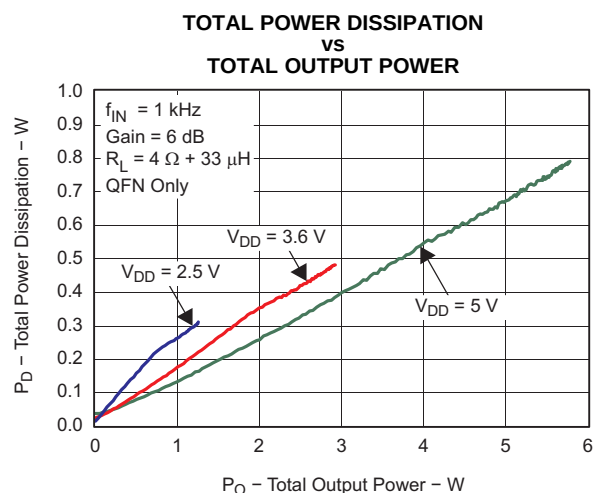


Figure 18.

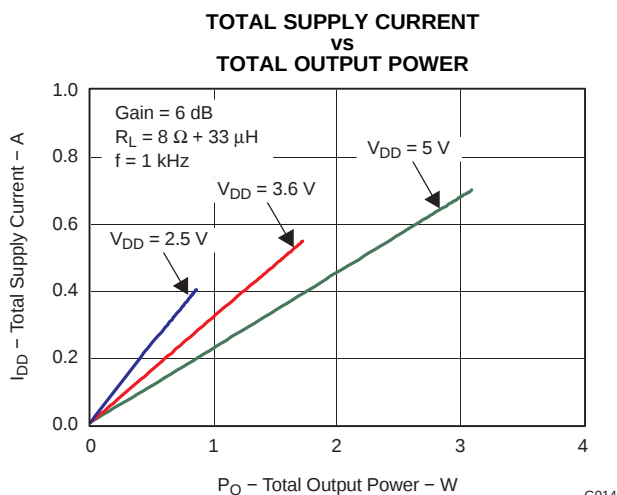


Figure 19.

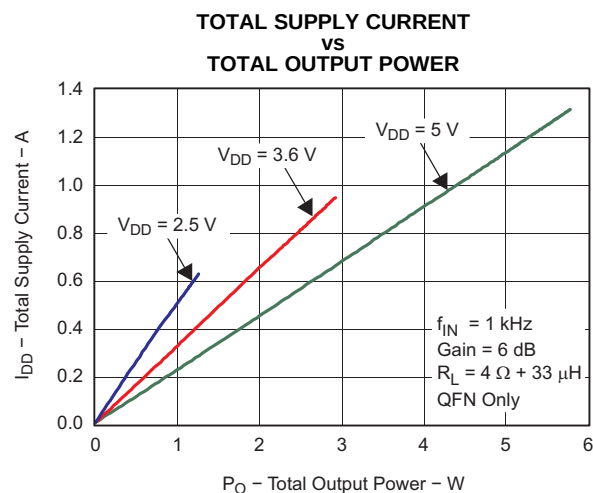


Figure 20.

TYPICAL CHARACTERISTICS (continued)

with $C_{(DECOUPLE)} = 1 \mu\text{F}$, $C_I = 1 \mu\text{F}$.

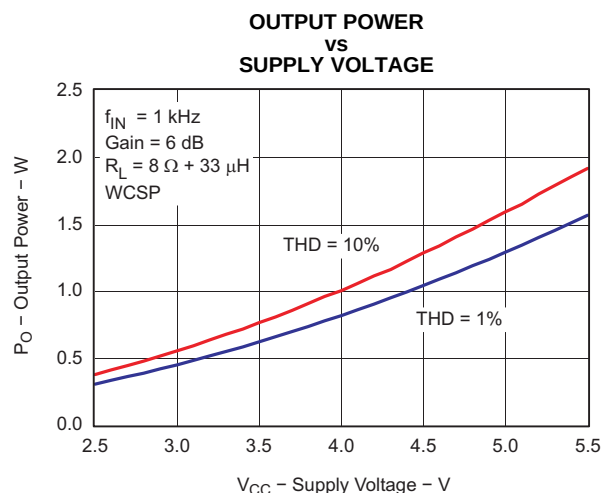


Figure 21.

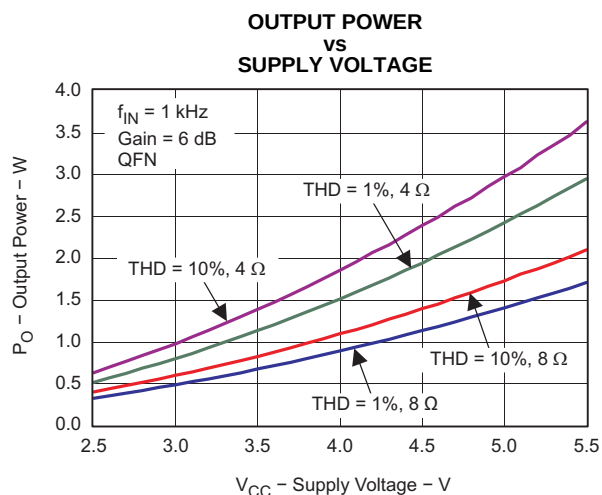


Figure 22.

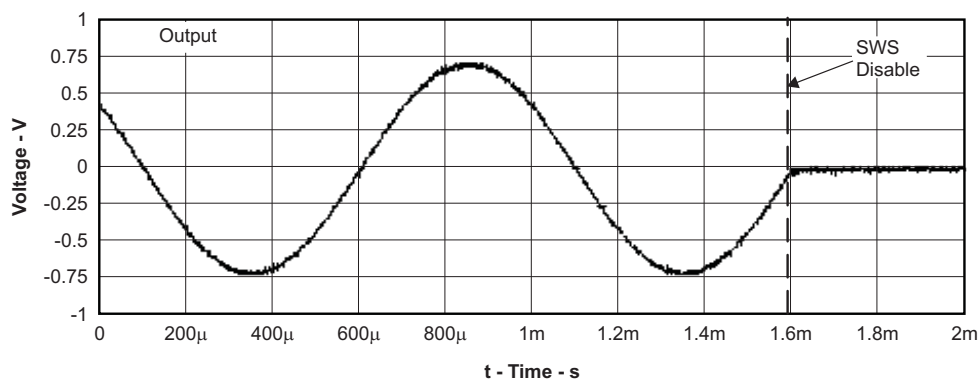


Figure 23. Shutdown Time

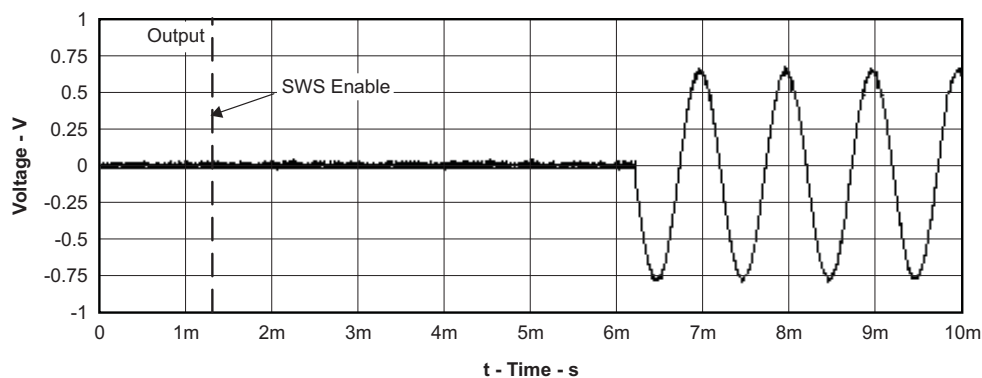


Figure 24. Startup Time

APPLICATION INFORMATION

AUTOMATIC GAIN CONTROL

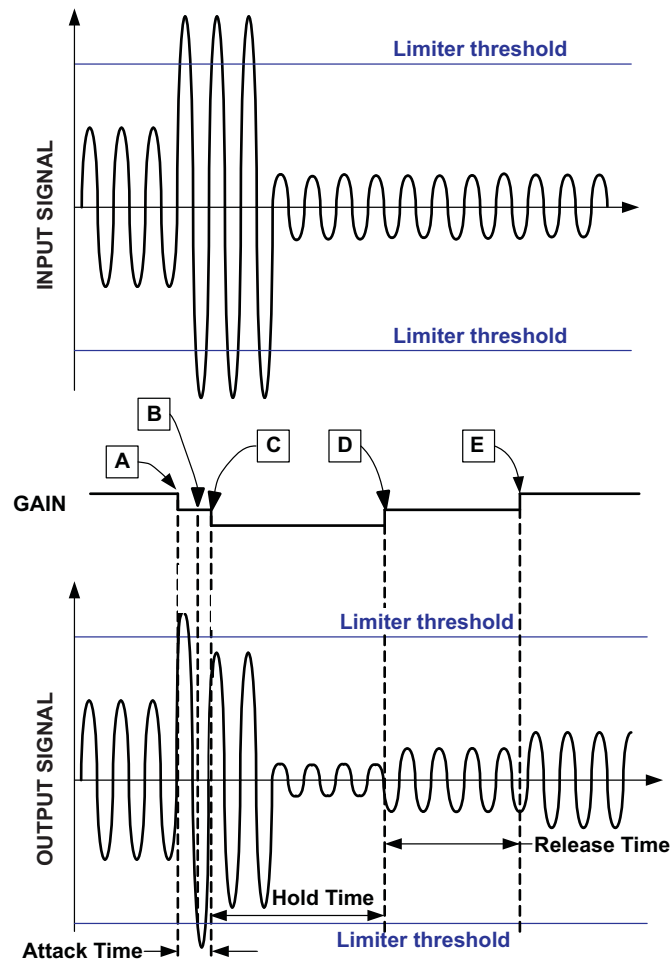
The Automatic Gain Control (AGC) feature provides continuous automatic gain adjustment to the amplifier through an internal PGA. This feature enhances the perceived audio loudness and at the same time prevents speaker damage from occurring (Limiter function).

The AGC function attempts to maintain the audio signal gain as selected by the user through the Fixed Gain, Limiter Level, and Compression Ratio variables. Other advanced features included are Maximum Gain and Noise Gate Threshold. [Table 1](#) describes the function of each variable in the AGC function.

Table 1. TPA2016D2 AGC Variable Descriptions

VARIABLE	DESCRIPTION
Maximum Gain	The gain at the lower end of the compression region.
Fixed Gain	The normal gain of the device when the AGC is inactive. The fixed gain is also the initial gain when the device comes out of shutdown mode or when the AGC is disabled.
Limiter Level	The value that sets the maximum allowed output amplitude.
Compression Ratio	The relation between input and output voltage.
Noise Gate Threshold	Below this value, the AGC holds the gain to prevent breathing effects.
Attack Time	The minimum time between two gain decrements.
Release Time	The minimum time between two gain increments.
Hold Time	The time it takes for the very first gain increment after the input signal amplitude decreases.

The AGC works by detecting the audio input envelope. The gain changes depending on the amplitude, the limiter level, the compression ratio, and the attack and release time. The gain changes constantly as the audio signal increases and/or decreases to create the compression effect. The gain step size for the AGC is 0.5 dB. If the audio signal has near-constant amplitude, the gain does not change. Figure 25 shows how the AGC works.



- A. Gain decreases with no delay; attack time is reset. Release time and hold time are reset.
- B. Signal amplitude above limiter level, but gain cannot change because attack time is not over.
- C. Attack time ends; gain is allowed to decrease from this point forward by one step. Gain decreases because the amplitude remains above limiter threshold. All times are reset
- D. Gain increases after release time finishes and signal amplitude remains below desired level. All times are reset after the gain increase.
- E. Gain increases after release time is finished again because signal amplitude remains below desired level. All times are reset after the gain increase.

Figure 25. Input and Output Audio Signal vs Time

Since the number of gain steps is limited the compression region is limited as well. The following figure shows how the gain changes vs. the input signal amplitude in the compression region.

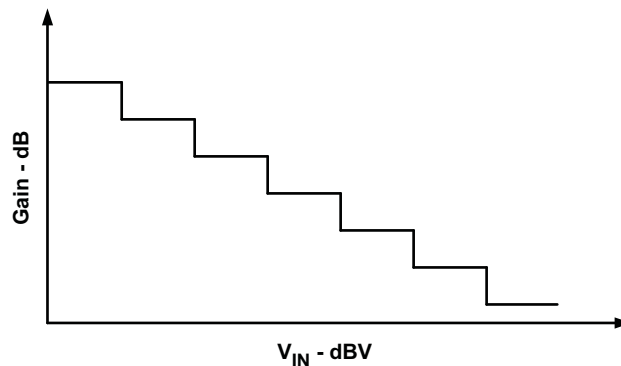


Figure 26. Input Signal Voltage vs Gain

Thus the AGC performs a mapping of the input signal vs. the output signal amplitude. This mapping can be modified according to the variables from [Table 1](#).

The following graphs and explanations show the effect of each variable to the AGC independently and which considerations should be taken when choosing values.

Fixed Gain: The fixed gain determines the initial gain of the AGC. Set the gain using the following variables:

- Set the fixed gain to be equal to the gain when the AGC is disabled.
- Set the fixed gain to maximize SNR.
- Set the fixed gain such that it will not overdrive the speaker.

[Figure 27](#) shows how the fixed gain influences the input signal amplitude vs. the output signal amplitude state diagram. The dotted 1:1 line is displayed for reference. The 1:1 line means that for a 1dB increase in the input signal, the output increases by 1dB.

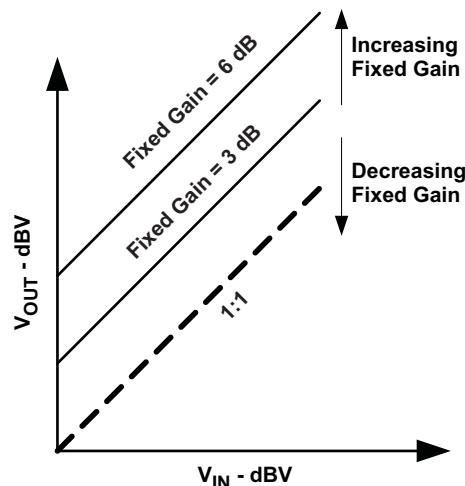


Figure 27. Output Signal vs Input Signal State Diagram Showing Different Fixed Gain Configurations

If the Compression function is enabled, the Fixed Gain is adjustable from –28dB to 30dB. If the Compression function is disabled, the Fixed gain is adjustable from 0dB to 30dB.

Limiter Level: The Limiter level sets the maximum amplitude allowed at the output of the amplifier. The limiter should be set with the following constraints in mind:

- Below or at the maximum power rating of the speaker
- Below the minimum supply voltage in order to avoid clipping

[Figure 28](#) shows how the limiter level influences the input signal amplitude vs. the output signal amplitude state diagram.

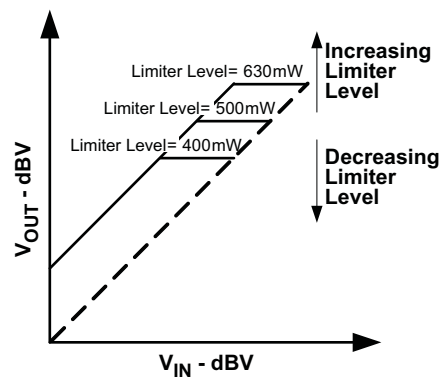


Figure 28. Output Signal vs Input Signal State Diagram Showing Different Limiter Level Configurations

The limiter level and the fixed gain influence each other. If the fixed gain is set high, the AGC has a large limiter range. The fixed gain is set low, the AGC has a short limiter range. Figure 29 illustrates the two examples:

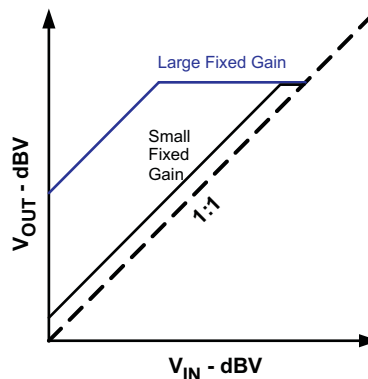


Figure 29. Output Signal vs. Input Signal State Diagram Showing Same Limiter Level Configurations with Different Fixed Gain Configurations

Compression Ratio: The compression ratio sets the relation between input and output signal outside the limiter level region. The compression ratio compresses the dynamic range of the audio. For example if the audio source has a dynamic range of 60dB and compression ratio of 2:1 is selected, then the output has a dynamic range of 30dB. Most small form factor speakers have small dynamic range. Compression ratio allows audio with large dynamic range to fit into a speaker with small dynamic range.

The compression ratio also increases the loudness of the audio without increasing the peak voltage. The higher the compression ratio, the louder the perceived audio.

For example:

- A compression ratio of 4:1 is selected (meaning that a 4dB change in the input signal results in a 1dB signal change at the output)
- A fixed gain of 0dB is selected and the maximum audio level is at 0dBV.

When the input signal decreases to –32dBV, the amplifier increases the gain to 24dB in order to achieve an output of –8dBV. The output signal amplitude equation is:

$$\text{Output signal amplitude} = \frac{\text{Input signal initial amplitude} - |\text{Current input signal amplitude}|}{\text{Compression ratio}} \quad (1)$$

In this example:

$$-8\text{dBV} = \frac{0\text{dBV} - |-32\text{dBV}|}{4} \quad (2)$$

The gain change equation is:

$$\text{Gain change} = \left(1 - \frac{1}{\text{Compression ratio}} \right) \times \text{Input signal change} \quad (3)$$

$$24 \text{ dB} = \left(1 - \frac{1}{4} \right) \times 32 \quad (4)$$

Consider the following when setting the compression ratio:

- Dynamic range of the speaker
- Fixed gain level
- Limiter Level
- Audio Loudness vs Output Dynamic Range.

Figure 30 shows different settings for dynamic range and different fixed gain selected but no limiter level.

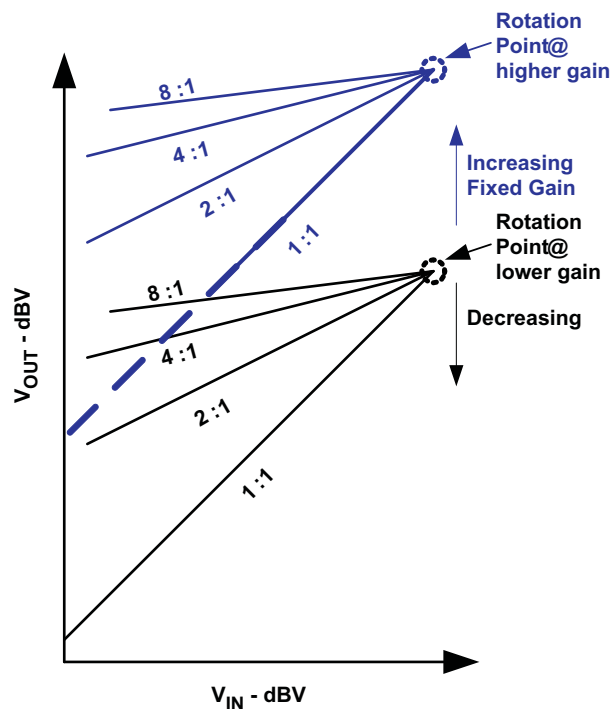


Figure 30. Output Signal vs Input Signal State Diagram Showing Different Compression Ratio Configurations with Different Fixed Gain Configurations

The rotation point is always at $V_{in} = 10\text{dBV}$. The rotation point is not located at the intersection of the limiter region and the compression region. By changing the fixed gain the rotation point will move in the y-axis direction only, as shown in the previous graph.

Interaction between compression ratio and limiter range: The compression ratio can be limited by the limiter range. Note that the limiter range is selected by the limiter level and the fixed gain.

For a setting with large limiter range, the amount of gain steps in the AGC remaining to perform compression are limited. Figure 31 shows two examples, where the fixed gain was changed.

1. Small limiter range yielding a large compression region (small fixed gain).
2. Large limiter range yielding a small compression region (large fixed gain).

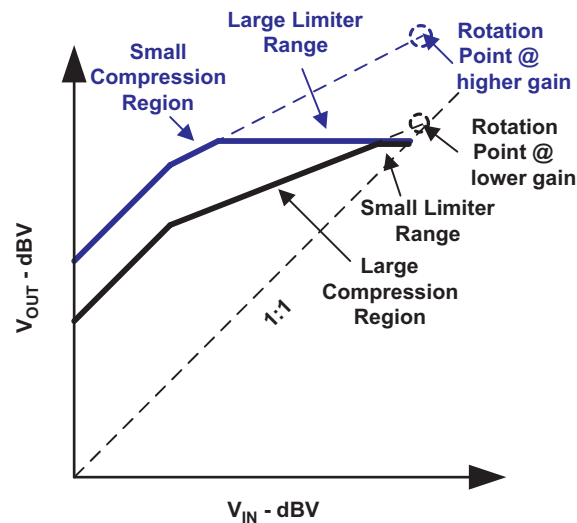


Figure 31. Output Signal vs Input Signal State Diagram Showing the Effects of the Limiter Range to the Compression Region

Noise Gate Threshold: The noise gate threshold prevents the AGC from changing the gain when there is no audio at the input of the amplifier. The noise gate threshold stops gain changes until the input signal is above the noise gate threshold. Select the noise gate threshold to be above the noise but below the minimum audio at the input of the amplifier signal. A filter is needed between delta-sigma CODEC/DAC and TPA2016D2 for effectiveness of the noise gate function. The filter eliminates the out-of-band noise from delta-sigma modulation and keeps the CODEC/DAC output noise lower than the noise gate threshold.

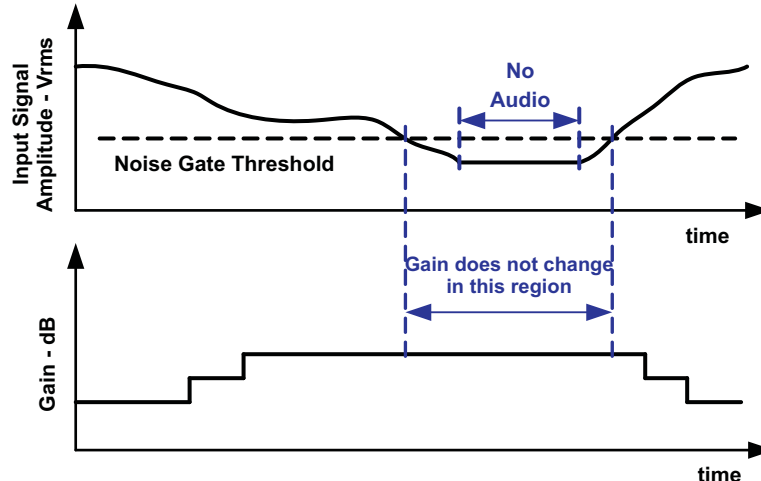


Figure 32. Time Diagram Showing the Relationship Between Input Signal Amplitude, Noise Gate Threshold and Gain Versus Time

Maximum Gain: This variable limits the number of gain steps in the AGC. This feature is useful in order to accomplish a more advanced output signal vs. input signal transfer characteristic.

For example, to prevent the gain from going above a certain value, reduce the maximum gain.

However, this variable will affect the limiter range and the compression region. If the maximum gain is decreased, the limiter range and/or compression region is reduced. [Figure 33](#) illustrates the effects.

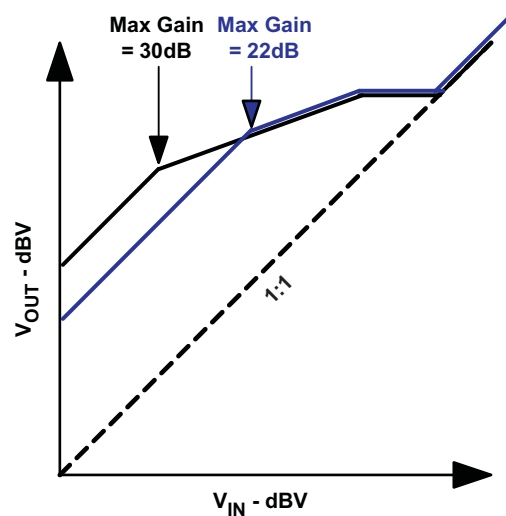


Figure 33. Output Signal vs. Input Signal State Diagram Showing Different Maximum Gains

A particular application requiring maximum gain of 22dB, for example. Thus, set the maximum gain at 22dB. The amplifier gain will never have a gain higher than 22dB; however, this will reduce the limiter range.

Attack, Release, and Hold time:

- The attack time is the minimum time between gain decreases.
- The release time is the minimum time between gain increases.
- The hold time is the minimum time between a gain decrease (attack) and a gain increase (release). The hold time can be deactivated. Hold time is only valid if greater than release time.

Successive gain decreases are never faster than the attack time. Successive gain increases are never faster than the release time.

All time variables (attack, release and hold) start counting after each gain change performed by the AGC. The AGC is allowed to decrease the gain (attack) only after the attack time finishes. The AGC is allowed to increase the gain (release) only after the release time finishes counting. However, if the preceding gain change was an attack (gain increase) and the hold time is enabled and longer than the release time, then the gain is only increased after the hold time.

The hold time is only enabled after a gain decrease (attack). The hold time replaces the release time after a gain decrease (attack). If the gain needs to be increased further, then the release time is used. The release time is used instead of the hold time if the hold time is disabled.

The attack time should be at least 100 times shorter than the release and hold time. The hold time should be the same or greater than the release time. It is important to select reasonable values for those variables in order to prevent the gain from changing too often or too slow.

Figure 34 illustrates the relationship between the three time variables.

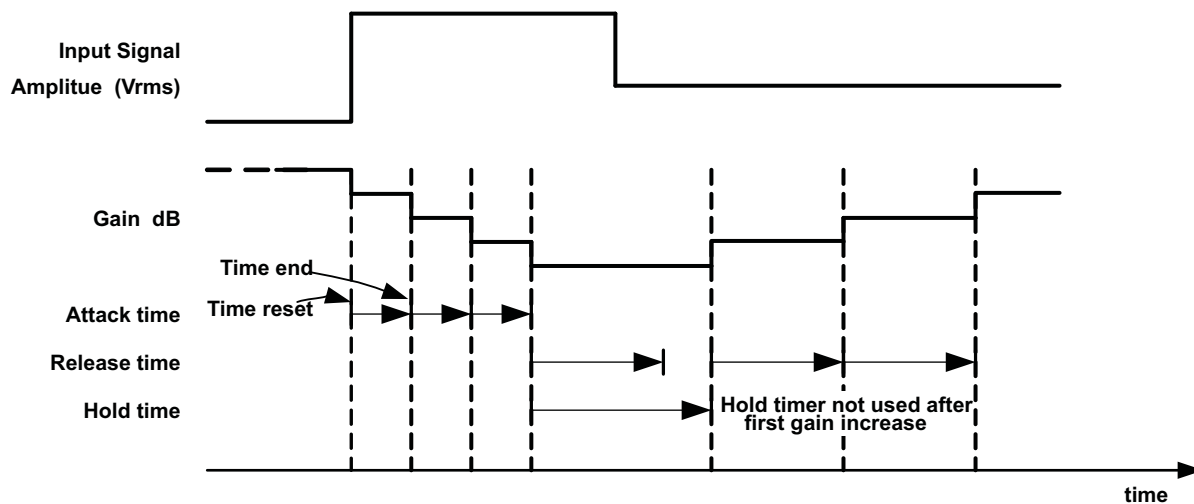


Figure 34. Time Diagram Showing the Relation Between the Attack, Release, and Hold Time vs Input Signal Amplitude and Gain

Figure 35 shows a state diagram of the input signal amplitude vs. the output signal amplitude and a summary of how the variables from table 1 described in the preceding pages affect them.

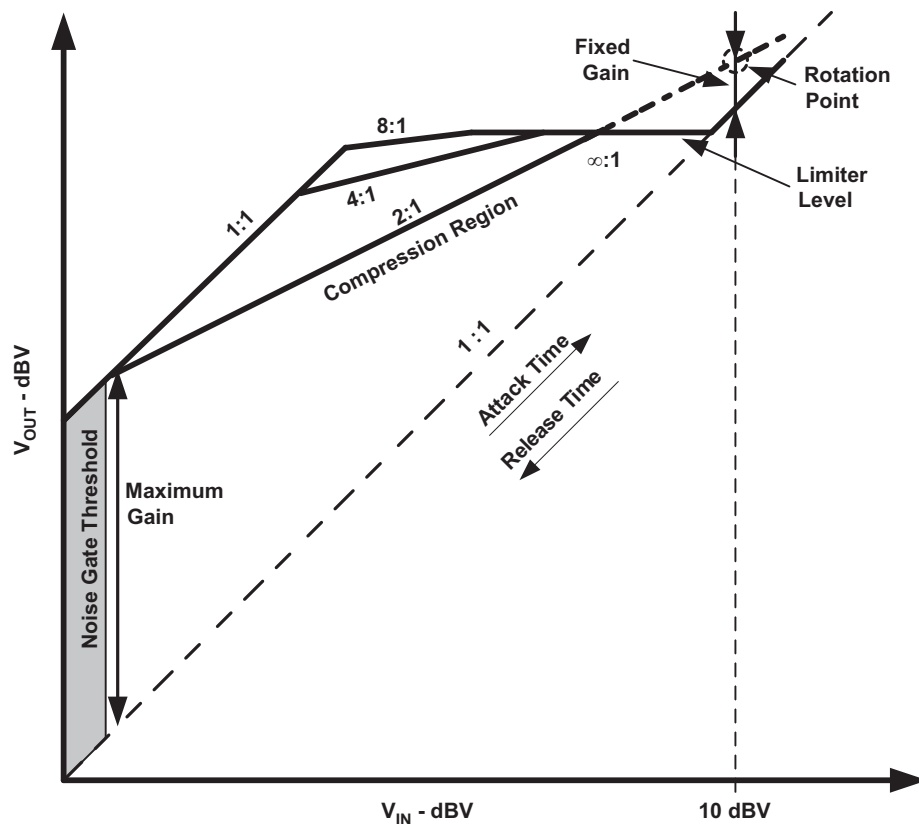


Figure 35. Output Signal vs. Input Signal State Diagram

TPA2016D2 AGC OPERATION

The TPA2016D2 is controlled by the I²C interface. The correct start-up sequence is:

1. Apply the supply voltage to the AV_{DD} and PV_{DD} (L, R) pins.
2. Apply a voltage above V_{IH} to the SDZ pin. The TPA2016D2 powers up the I²C interface and the control logic. By default, the device is in active mode (SWS = 0). After a few milliseconds the amplifier will enable the class-D output stage and become fully operational.
3. The amplifier starts at a gain of 0 dB and the AGC starts ramping the gain after the input signal exceeds the noise gate threshold.

CAUTION:

Do not interrupt the start-up sequence after changing SDZ from V_{IL} to V_{IH}.

Do not interrupt the start-up sequence after changing SWS from 1 to 0.

The default conditions of TPA2016D2 allows audio playback without I2C control. Refer to [Table 4](#) for entire default conditions.

There are several options to disable the amplifier:

- Write SPK_EN_R = 0 and SPK_EN_L = 0 to the register (0x01, 6 and 0x01, 7). This write disables each speaker amplifier, but leaves all other circuits operating.
- Write SWS = 1 to the register (0x01, 5). This action disables most of the amplifier functions.
- Apply V_{IL} to SDZ. This action shuts down all the circuits and has very low quiescent current consumption. This action resets the registers to its default values.

CAUTION:

Do not interrupt the shutdown sequence after changing SDZ from V_{IH} to V_{IL}.

Do not interrupt the shutdown sequence after changing SWS from 0 to 1.

TPA2016D2 AGC RECOMMENDED SETTINGS

Table 2. Recommended AGC Settings for Different Types of Audio Source (V_{DD} = 3.6V)

AUDIO SOURCE	COMPRESSION RATIO	ATTACK TIME (ms/6 dB)	RELEASE TIME (ms/6 dB)	HOLD TIME (ms)	FIXED GAIN (dB)	LIMITER LEVEL (dBV)
Pop Music	4:1	1.28 to 3.84	986 to 1640	137	6	7.5
Classical	2:1	2.56	1150	137	6	8
Jazz	2:1	5.12 to 10.2	3288	—	6	8
Rap/ Hip Hop	4:1	1.28 to 3.84	1640	—	6	7.5
Rock	2:1	3.84	4110	—	6	8
Voice/ News	4:1	2.56	1640	—	6	8.5

GENERAL I²C OPERATION

The I²C bus employs two signals, SDA (data) and SCL (clock), to communicate between integrated circuits in a system. The bus transfers data serially one bit at a time. The address and data 8-bit bytes are transferred most significant bit (MSB) first. In addition, each byte transferred on the bus is acknowledged by the receiving device with an *acknowledge* bit. Each transfer operation begins with the master device driving a start condition on the bus and ends with the master device driving a stop condition on the bus. The bus uses transitions on the data terminal (SDA) while the clock is at logic high to indicate start and stop conditions. A high-to-low transition on SDA indicates a start and a low-to-high transition indicates a stop. Normal data-bit transitions must occur within the low time of the clock period. [Figure 36](#) shows a typical sequence. The master generates the 7-bit slave

address and the read/write (R/W) bit to open communication with another device, and then waits for an acknowledge condition. The TPA2016D2 holds SDA low during the acknowledge clock period to indicate acknowledgment. When this acknowledgment occurs, the master transmits the next byte of the sequence. Each device is addressed by a unique 7-bit slave address plus R/W bit (1 byte). All compatible devices share the same signals via a bidirectional bus using a wired-AND connection.

An external pull-up resistor must be used for the SDA and SCL signals to set the logic high level for the bus. When the bus level is 5 V, use pull-up resistors between 1 k Ω and 2 k Ω .

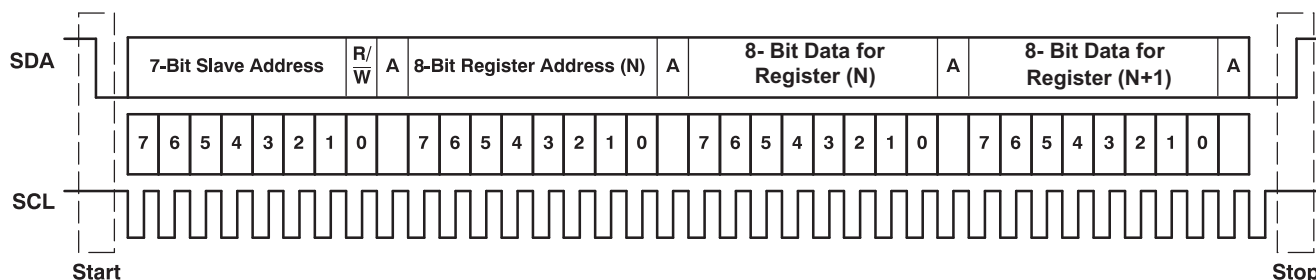


Figure 36. Typical I²C Sequence

There is no limit on the number of bytes that can be transmitted between start and stop conditions. When the last word transfers, the master generates a stop condition to release the bus. A generic data transfer sequence is shown in [Figure 36](#).

SINGLE-AND MULTIPLE-BYTE TRANSFERS

The serial control interface supports both single-byte and multi-byte read/write operations for all registers.

During multiple-byte read operations, the TPA2016D2 responds with data, one byte at a time, starting at the register assigned, as long as the master device continues to respond with acknowledgments.

The TPA2016D2 supports sequential I²C addressing. For write transactions, if a register is issued followed by data for that register and all the remaining registers that follow, a sequential I²C write transaction has occurred. For I²C sequential write transactions, the register issued then serves as the starting point, and the amount of data subsequently transmitted, before a stop or start is transmitted, determines the number of registers written.

SINGLE-BYTE WRITE

As [Figure 37](#) shows, a single-byte data write transfer begins with the master device transmitting a start condition followed by the I²C device address and the read/write bit. The read/write bit determines the direction of the data transfer. For a write data transfer, the read/write bit must be set to '0'. After receiving the correct I²C device address and the read/write bit, the TPA2016D2 responds with an acknowledge bit. Next, the master transmits the register byte corresponding to the TPA2016D2 internal memory address being accessed. After receiving the register byte, the TPA2016D2 again responds with an acknowledge bit. Next, the master device transmits the data byte to be written to the memory address being accessed. After receiving the register byte, the TPA2016D2 again responds with an acknowledge bit. Finally, the master device transmits a stop condition to complete the single-byte data write transfer.

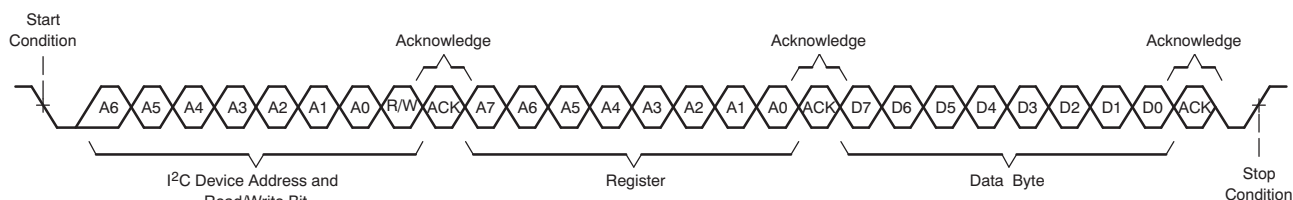


Figure 37. Single-Byte Write Transfer

MULTIPLE-BYTE WRITE AND INCREMENTAL MULTIPLE-BYTE WRITE

A multiple-byte data write transfer is identical to a single-byte data write transfer except that multiple data bytes are transmitted by the master device to the TPA2016D2 as shown in Figure 38. After receiving each data byte, the TPA2016D2 responds with an acknowledge bit.

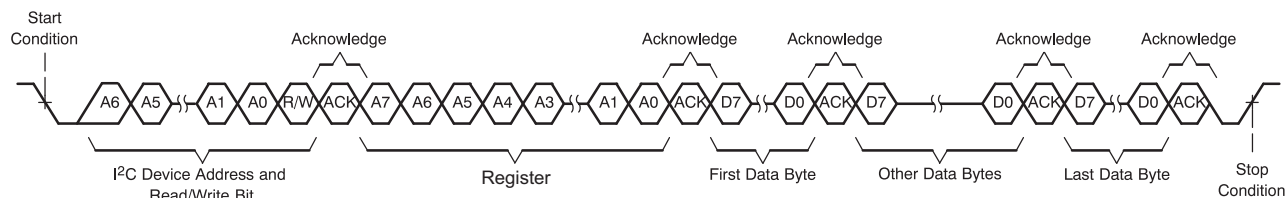


Figure 38. Multiple-Byte Write Transfer

SINGLE-BYTE READ

As Figure 39 shows, a single-byte data read transfer begins with the master device transmitting a start condition followed by the I²C device address and the read/write bit. For the data read transfer, both a write followed by a read are actually executed. Initially, a write is executed to transfer the address byte of the internal memory address to be read. As a result, the read/write bit is set to a '0'.

After receiving the TPA2016D2 address and the read/write bit, the TPA2016D2 responds with an acknowledge bit. The master then sends the internal memory address byte, after which the TPA2016D2 issues an acknowledge bit. The master device transmits another start condition followed by the TPA2016D2 address and the read/write bit again. This time the read/write bit is set to '1', indicating a read transfer. Next, the TPA2016D2 transmits the data byte from the memory address being read. After receiving the data byte, the master device transmits a *not-acknowledge* followed by a stop condition to complete the single-byte data read transfer.

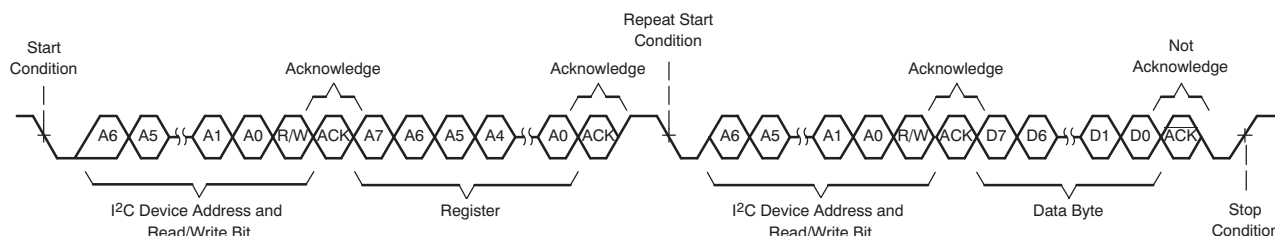


Figure 39. Single-Byte Read Transfer

MULTIPLE-BYTE READ

A multiple-byte data read transfer is identical to a single-byte data read transfer except that multiple data bytes are transmitted by the TPA2016D2 to the master device as shown in Figure 40. With the exception of the last data byte, the master device responds with an acknowledge bit after receiving each data byte.

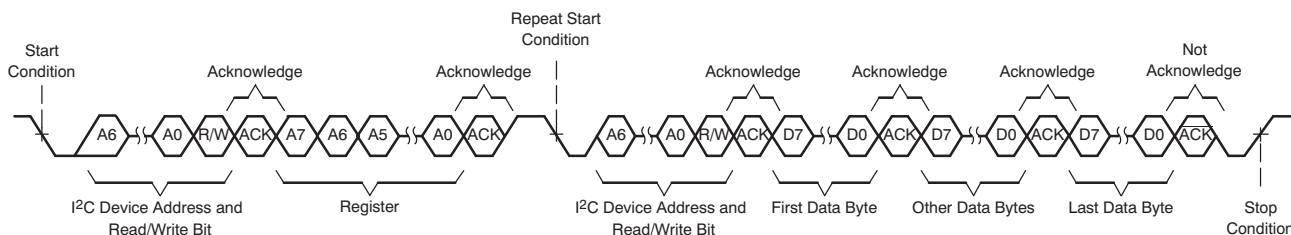


Figure 40. Multiple-Byte Read Transfer

Register Map

Table 3. TPA2016D2 Register Map

Register	Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0
1	SPK_EN_R	SPL_EN_L	SWS	FAULT_R	FAULT_L	Thermal	1	NG_EN
2	0	0	ATK_time [5]	ATK_time [4]	ATK_time [3]	ATK_time [2]	ATK_time [1]	ATK_time [0]
3	0	0	REL_time [5]	REL_time [4]	REL_time [3]	REL_time [2]	REL_time [1]	REL_time [0]
4	0	0	Hold_time [5]	Hold_time [4]	Hold_tme [3]	Hold_time [2]	Hold_time [1]	Hold_time [0]
5	0	0	FixedGain [5]	FixedGain [4]	FixedGain [3]	FixedGain [2]	FixedGain [1]	FixedGain [0]
6	Output Limiter Disable	NoiseGate Threshold [1]	NoiseGate Threshold [2]	Output Limiter Level [4]	Output Limiter Level [3]	Output Limiter Level [2]	Output Limiter Level [1]	Output Limiter Level [0]
7	Max Gain [3]	Max Gain [2]	Max Gain [1]	Max Gain [0]	0	0	Compression Ratio [1]	Compression Ratio [0]

The default register map values are given in [Table 4](#).

Table 4. TPA2016D2 Default Register Values Table

Register	0x01	0x02	0x03	0x04	0x05	0x06	0x07
Default	C3h	05h	0Bh	00h	06h	3Ah	C2h

Any register above address 0x08 is reserved for testing and should not be written to because it may change the function of the device. If read, these bits may assume any value.

Some of the default values can be reprogrammed through the I²C interface and written to the EEPROM. This function is useful to speed up the turn-on time of the device and minimizes the number of I²C writes. If this is required, contact your local TI representative.

The TPA2016D2 I²C address is 0xB0 (binary 10110000) for writing and 0xB1 (binary 10110001) for reading. If a different I²C address is required, please contact your local TI representative. See the General I2C operation section for more detail.

The following tables show the details of the registers, the default values, and the values that can be programmed through the I²C interface.

IC FUNCTION CONTROL (Address: 1)

REGISTER ADDRESS	I2C BIT	LABEL	DEFAULT	DESCRIPTION
01 (01 _H) – IC Function Control	7	SPK_EN_R	1 (enabled)	Enables right amplifier
	6	SPK_EN_L	1 (enabled)	Enables left amplifier
	5	SWS	0 (enabled)	Shutdown IC when bit = 1
	4	FAULT_R	0	Changes to a 1 when there is a short on the right channel. Reset by writing a 0.
	3	FAULT_L	0	Changes to a 1 when there is a short on the left channel. Reset by writing a 0
	2	Thermal	0	Changes to a 1 when die temperature is above 150°C
	1	UNUSED	1	
	0	NG_EN	1 (enabled)	Enables Noise Gate function

- SPK_EN_R:** Enable bit for the right-channel amplifier. Amplifier is active when bit is high. This function is gated by thermal and returns once the IC is below the threshold temperature.
- SPK_EN_L:** Enable bit for the left-channel amplifier. Amplifier is active when bit is high. This function is gated by thermal and returns once the IC is below the threshold temperature
- SWS:** Software shutdown control. The device is in software shutdown when the bit is '1' (control, bias and oscillator are inactive). When the bit is '0' the control, bias and oscillator are enabled.
- Fault_L:** This bit indicates that an over-current event has occurred on the left channel with a '1'. This bit is cleared by writing a '0' to it.
- Fault_R:** This bit indicates that an over-current event has occurred on the right channel with a '1'. This bit is cleared by writing a '0' to it.
- Thermal:** This bit indicates a thermal shutdown that was initiated by the hardware with a '1'. This bit is deglitched and latched, and can be cleared by writing a '0' to it.
- NG_EN:** Enable bit for the Noise Gate function. This function is enabled when this bit is high. This function can only be enabled when the Compression ratio is not 1:1.

AGC ATTACK CONTROL (Address: 2)

REGISTER ADDRESS	I ² C BIT	LABEL	DEFAULT	DESCRIPTION			
02 (02 _H) – AGC Control	7:6	Unused	00				
	5:0	ATK_time	000101 (6.4 ms/6 dB)	AGC Attack time (gain ramp down)			
					Per Step	Per 6 dB	90% Range
				000001	0.1067 ms	1.28 ms	5.76 ms
				000010	0.2134 ms	2.56 ms	11.52 ms
				000011	0.3201 ms	3.84 ms	17.19 ms
				000100	0.4268 ms	5.12 ms	23.04 ms
				(time increases by 0.1067 ms with every step)			
				111111	6.722 ms	80.66 ms	362.99 ms

- ATK_time** These bits set the attack time for the AGC function. The attack time is the minimum time between gain decreases.

AGC RELEASE CONTROL (Address: 3)

REGISTER ADDRESS	I ² C BIT	LABEL	DEFAULT	DESCRIPTION			
03 (03 _H) – AGC Release Control	7:6	Unused	00				
	5:0	REL_time	001011 (1.81 sec/6 dB)	AGC Release time (gain ramp down)			
					Per Step	Per 6 dB	90% Range
				000001	0.0137 s	0.1644 s	0.7398 s
				000010	0.0274 s	0.3288 s	1.4796 s
				000011	0.0411 s	0.4932 s	2.2194 s
				000100	0.0548 s	0.6576 s	2.9592 s
				(time increases by 0.0137 s with every step)			
				111111	0.8631 s	10.36 s	46.6 s

REL_time These bits set the release time for the AGC function. The release time is the minimum time between gain increases.

AGC HOLD TIME CONTROL (Address: 4)

REGISTER ADDRESS	I ² C BIT	LABEL	DEFAULT	DESCRIPTION		
04 (04 _H) – AGC Hold Time Control	7:6	Unused	00			
	5:0	Hold_time	000000 (Disabled)	AGC Hold time		
						Per Step
				000000	Hold Time Disable	
				000001	0.0137 s	
				000010	0.0274 s	
				000011	0.0411 s	
				000100	0.0548 s	
				(time increases by 0.0137 s with every step)		
	111111	0.8631 s				

Hold_time These bits set the hold time for the AGC function. The hold time is the minimum time between a gain decrease (attack) and a gain increase (release). The hold time can be deactivated.

AGC FIXED GAIN CONTROL (Address: 5)

REGISTER ADDRESS	I ² C BIT	LABEL	DEFAULT	DESCRIPTION		
05 (05 _H) – AGC Fixed Gain Control	7:6	Unused	00			
	5:0	Fixed Gain	00110 (6dB)	Sets the fixed gain of the amplifier: two's compliment		
					Gain	
					100100	–28 dB
					100101	–27 dB
					100110	–26 dB
				(gain increases by 1 dB with every step)		
					111101	–3 dB
					111110	–2 dB
					111111	–1 dB
					000000	0 dB
					000001	1 dB
					000010	2 dB
					000011	3 dB
				(gain increases by 1dB with every step)		
					011100	28 dB
					011101	29 dB
					011110	30 dB

Fixed Gain

These bits are used to select the fixed gain of the amplifier. If the Compression is enabled, fixed gain is adjustable from –28dB to 30dB. If the Compression is disabled, fixed gain is adjustable from 0dB to 30dB.

AGC CONTROL (Address: 6)

REGISTER ADDRESS	I ² C BIT	LABEL	DEFAULT	DESCRIPTION
06 (06 _H) – AGC Control	7	Output Limiter Disable	0 (enable)	Disables the output limiter function. Can only be disabled when the AGC compression ratio is 1:1 (off)
	6:5	NoiseGate Threshold	01 (4mV _{rms})	Select the threshold of the noise gate
				Threshold
				00 1 mV _{rms}
				01 4 mV _{rms}
				10 10 mV _{rms}
				11 20 mV _{rms}
	4:0	Output Limiter Level	11010 (6.5dBV)	Selects the output limiter level
				Output Power (Wrms) Peak Output Voltage (Vp) dBV
				00000 0.03 0.67 –6.5
				00001 0.03 0.71 –6
				00010 0.04 0.75 –5.5
				(Limiter level increases by 0.5dB with every step)
				11101 0.79 3.55 8
				11110 0.88 3.76 8.5
				11111 0.99 3.99 9

Output Limiter Disable This bit disables the output limiter function when set to 1. Can only be disabled when the AGC compression ratio is 1:1

NoiseGate Threshold These bits set the threshold level of the noise gate. NoiseGate Threshold is only functional when the compression ratio is not 1:1

Output Limiter Level These bits select the output limiter level. Output Power numbers are for 8Ω load.

AGC CONTROL (Address: 7)

REGISTER ADDRESS	I ² C BIT	LABEL	DEFAULT	DESCRIPTION
07 (07 _H) – AGC Control	7:4	Max Gain	1100 (30 dB)	Selects the maximum gain the AGC can achieve
				Gain
				0000 18 dB
				0001 19 dB
				0010 20 dB
				(gain increases by 1 dB with every step)
				1100 30 dB
	3:2	Unused	00	
	1:0	Compression Ratio	10 (4:1)	Selects the compression ratio of the AGC
				Ratio
				00 1:1 (off)
				01 2:1
				10 4:1
				11 8:1

Compression Ratio These bits select the compression ratio. Output Limiter is enabled by default when the compression ratio is not 1:1.

Max Gain These bits select the maximum gain of the amplifier. In order to maximize the use of the AGC, set the Max Gain to 30dB

DECOUPLING CAPACITOR = s)

The TPA2016D2 is a high-performance Class-D audio amplifier that requires adequate power supply decoupling to ensure the efficiency is high and total harmonic distortion (THD) is low. For higher frequency transients, spikes, or digital hash on the line, a good low equivalent-series-resistance (ESR) 1-μF ceramic capacitor (typically) placed as close as possible to the device PVDD (L, R) lead works best. Placing this decoupling capacitor close to the TPA2016D2 is important for the efficiency of the Class-D amplifier, because any resistance or inductance in the trace between the device and the capacitor can cause a loss in efficiency. For filtering lower-frequency noise signals, a 4.7 μF or greater capacitor placed near the audio power amplifier would also help, but it is not required in most applications because of the high PSRR of this device.

INPUT CAPACITORS = i)

The input capacitors and input resistors form a high-pass filter with the corner frequency, f_c , determined in [Equation 5](#).

$$f_c = \frac{1}{(2\pi \times R_i \times C_i)} \quad (5)$$

The value of the input capacitor is important to consider as it directly affects the bass (low frequency) performance of the circuit. Speakers in wireless phones cannot usually respond well to low frequencies, so the corner frequency can be set to block low frequencies in this application. Not using input capacitors can increase output offset. [Equation 6](#) is used to solve for the input coupling capacitance. If the corner frequency is within the audio band, the capacitors should have a tolerance of ±10% or better, because any mismatch in capacitance causes an impedance mismatch at the corner frequency and below.

$$C_i = \frac{1}{(2\pi \times R_i \times f_c)} \quad (6)$$

BOARD LAYOUT

In making the pad size for the WCSP balls, it is recommended that the layout use non solder mask defined (NSMD) land. With this method, the solder mask opening is made larger than the desired land area, and the opening size is defined by the copper pad width. [Figure 41](#) and [Table 5](#) shows the appropriate diameters for a WCSP layout. The TPA2016D2 evaluation module (EVM) layout is shown in the next section as a layout example.

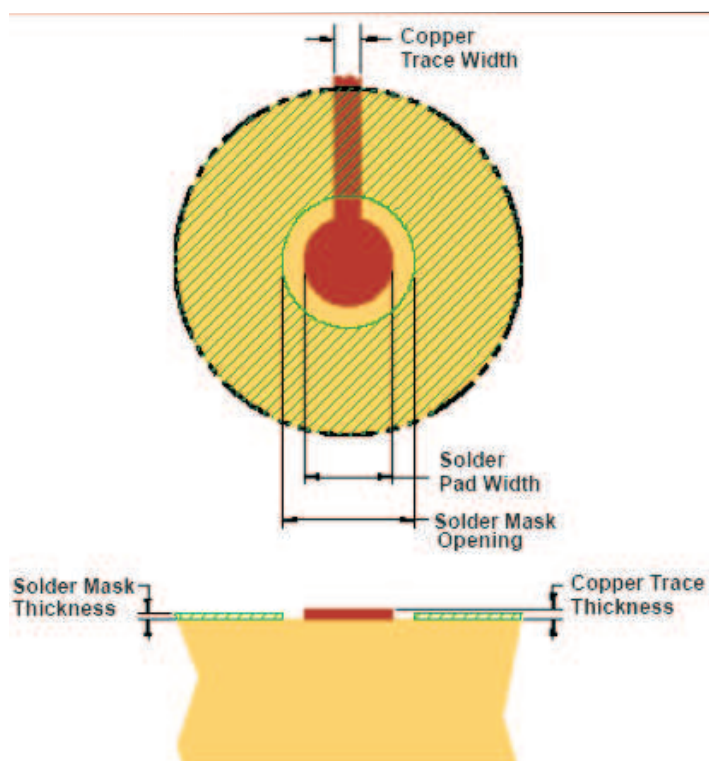


Figure 41. Land Pattern Dimensions

Table 5. Land Pattern Dimensions^{(1) (2) (3) (4)}

SOLDER PAD DEFINITIONS	COPPER PAD	SOLDER MASK ⁽⁵⁾ OPENING	COPPER THICKNESS	STENCIL ^{(6) (7)} OPENING	STENCIL THICKNESS
Non solder mask defined (NSMD)	275 μm (+0.0, -25 μm)	375 μm (+0.0, -25 μm)	1 oz max (32 μm)	275 μm $\times$ 275 μm Sq. (rounded corners)	125 μm thick

- (1) Circuit traces from NSMD defined PWB lands should be 75 μm to 100 μm wide in the exposed area inside the solder mask opening. Wider trace widths reduce device stand off and impact reliability.
- (2) Best reliability results are achieved when the PWB laminate glass transition temperature is above the operating the range of the intended application.
- (3) Recommend solder paste is Type 3 or Type 4.
- (4) For a PWB using a Ni/Au surface finish, the gold thickness should be less 0.5 μm to avoid a reduction in thermal fatigue performance.
- (5) Solder mask thickness should be less than 20 μm on top of the copper circuit pattern
- (6) Best solder stencil performance is achieved using laser cut stencils with electro polishing. Use of chemically etched stencils results in inferior solder paste volume control.
- (7) Trace routing away from WCSP device should be balanced in X and Y directions to avoid unintentional component movement due to solder wetting forces.

COMPONENT LOCATION

Place all the external components very close to the TPA2016D2. Placing the decoupling capacitor, C_S , close to the TPA2016D2 is important for the efficiency of the Class-D amplifier. Any resistance or inductance in the trace between the device and the capacitor can cause a loss in efficiency.

TRACE WIDTH

Recommended trace width at the solder balls is 75 μm to 100 μm to prevent solder wicking onto wider PCB traces. For high current pins (PVDD (L, R), PGND, and audio output pins) of the TPA2016D2, use 100- μm trace widths at the solder balls and at least 500- μm PCB traces to ensure proper performance and output power for the device. For the remaining signals of the TPA2016D2, use 75- μm to 100- μm trace widths at the solder balls. The audio input pins (INR $\pm$ and INL $\pm$) must run side-by-side to maximize common-mode noise cancellation

EFFICIENCY AND THERMAL INFORMATION

The maximum ambient temperature depends on the heat-sinking ability of the PCB system. The derating factor for the packages are shown in the dissipation rating table. Converting this to θ_{JA} for the WCSP package:

$$\theta_{JA} = \frac{1}{\text{Derating Factor}} = \frac{1}{0.01} = 100^{\circ}\text{C/W} \quad (7)$$

Given θ_{JA} of 100°C/W , the maximum allowable junction temperature of 150°C , and the maximum internal dissipation of 0.4 W (0.2 W per channel) for 1.5 W per channel, 8- Ω load, 5-V supply, from Figure 15, the maximum ambient temperature can be calculated with the following equation.

$$T_{A\text{Max}} = T_{J\text{Max}} - \theta_{JA} P_{D\text{MAX}} = 150 - 100 (0.4) = 110^{\circ}\text{C} \quad (8)$$

Equation 8 shows that the calculated maximum ambient temperature is 110°C at maximum power dissipation with a 5-V supply and 8- Ω a load. The TPA2016D2 is designed with thermal protection that turns the device off when the junction temperature surpasses 150°C to prevent damage to the IC. Also, using speakers more resistive than 8- Ω dramatically increases the thermal performance by reducing the output current and increasing the efficiency of the amplifier.

OPERATION WITH DACS AND CODECS

In using Class-D amplifiers with CODECs and DACs, sometimes there is an increase in the output noise floor from the audio amplifier. This occurs when mixing of the output frequencies of the CODEC/DAC mix with the switching frequencies of the audio amplifier input stage. The noise increase can be solved by placing a low-pass filter between the CODEC/DAC and audio amplifier. This filters off the high frequencies that cause the problem and allow proper performance. See the functional block diagram.

FILTER FREE OPERATION AND FERRITE BEAD FILTERS

A ferrite bead filter can often be used if the design is failing radiated emissions without an LC filter and the frequency sensitive circuit is greater than 1 MHz. This filter functions well for circuits that just have to pass FCC and CE because FCC and CE only test radiated emissions greater than 30 MHz. When choosing a ferrite bead, choose one with high impedance at high frequencies, and low impedance at low frequencies. In addition, select a ferrite bead with adequate current rating to prevent distortion of the output signal.

Use an LC output filter if there are low frequency (< 1 MHz) EMI sensitive circuits and/or there are long leads from amplifier to speaker. Figure 42 shows typical ferrite bead and LC output filters.

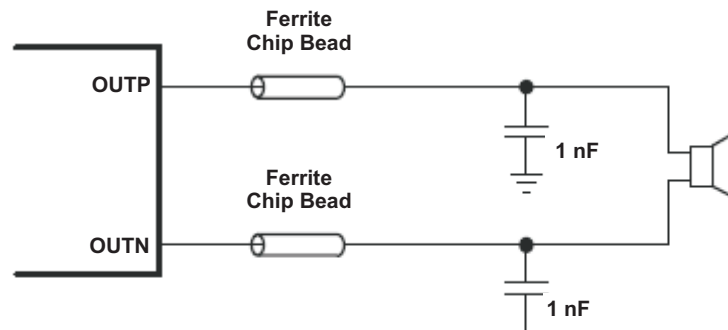


Figure 42. Typical Ferrite Bead Filter (Chip bead example: TDK: MPZ1608S221A)

Revision History

Changes from Original (June 2008) to Revision A Page

- Changed From: 1.4 W/Ch Into 8 Ω at 5 V (10% THD+N) To: 1.7 W/Ch Into 8 Ω at 5 V (10% THD+N)..... 1

Changes from Revision A (June 2008) to Revision B Page

- Changed Feature High PSRR From: 75 dB at 217 Hz To: 80 dB 1
- Added 00 to Default column 23
- Added 00 to Default column 24
- Added 00 to Default column 24

Changes from Revision B (June 2008) to Revision C Page

- Changed R_{LOAD} from 6.4 Ω to 3.2 Ω 3

Changes from Revision C (October 2008) to Revision D Page

- Added Feature: 2.8 W/Ch Into 4 Ω at 5 V (10% THD+N)..... 1
- Added Feature: 1.5 W/Ch Into 4 Ω at 3.6 V (10% THD+N)..... 1
- Added the RTJ (QFN) package. 1
- Added the RTJ (QFN) pin out package. 2
- Added the RTJ (QFN) package to the Dissipation Ratings Table. 3
- Changed the RTJ Package Options to the Available Options Table. 4
- Changed I_{SWS} Softwre shutdown 3.6V From: Max 60 To: 70 A 4
- Changed I_{SWS} Softwre shutdown 5.5V From: Max 100 to 110 A..... 4
- Changed Output offset TYP From 0 mV To: 2 mV 4
- Added text notes 4 and 5 to the Test Set-Up for Graphs. 5
- Deleted Table of Graphs from the Typical Characteristics. 7
- Added 4 Ω Efficiency Graph 9
- Added 4 Ω Total Power Dissipation Graph..... 9
- Added 4 Ω Total Supply Current Graph..... 9
- Added QFN Output Power Graph..... 10

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish	MSL Peak Temp (3)	Op Temp (°C)	Top-Side Markings (4)	Samples
TPA2016D2RTJR	ACTIVE	QFN	RTJ	20	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	TPA 2016D2	Samples
TPA2016D2RTJT	ACTIVE	QFN	RTJ	20	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	TPA 2016D2	Samples
TPA2016D2YZHR	ACTIVE	DSBGA	YZH	16	3000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 85	CCJ	Samples
TPA2016D2YZHT	ACTIVE	DSBGA	YZH	16	250	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 85	CCJ	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBsolete: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) Multiple Top-Side Markings will be inside parentheses. Only one Top-Side Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Top-Side Marking for that device.

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TAPE AND REEL INFORMATION


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TPA2016D2RTJR	QFN	RTJ	20	3000	330.0	12.4	4.25	4.25	1.15	8.0	12.0	Q2
TPA2016D2RTJR	QFN	RTJ	20	3000	330.0	12.4	4.3	4.3	1.1	8.0	12.0	Q2
TPA2016D2RTJT	QFN	RTJ	20	250	180.0	12.4	4.3	4.3	1.1	8.0	12.0	Q2
TPA2016D2RTJT	QFN	RTJ	20	250	180.0	12.4	4.25	4.25	1.15	8.0	12.0	Q2
TPA2016D2YZHR	DSBGA	YZH	16	3000	178.0	8.4	2.18	2.18	0.81	4.0	8.0	Q1
TPA2016D2YZHR	DSBGA	YZH	16	3000	180.0	8.4	2.18	2.18	0.81	4.0	8.0	Q1
TPA2016D2YZHT	DSBGA	YZH	16	250	180.0	8.4	2.18	2.18	0.81	4.0	8.0	Q1
TPA2016D2YZHT	DSBGA	YZH	16	250	178.0	8.4	2.18	2.18	0.81	4.0	8.0	Q1

TAPE AND REEL BOX DIMENSIONS

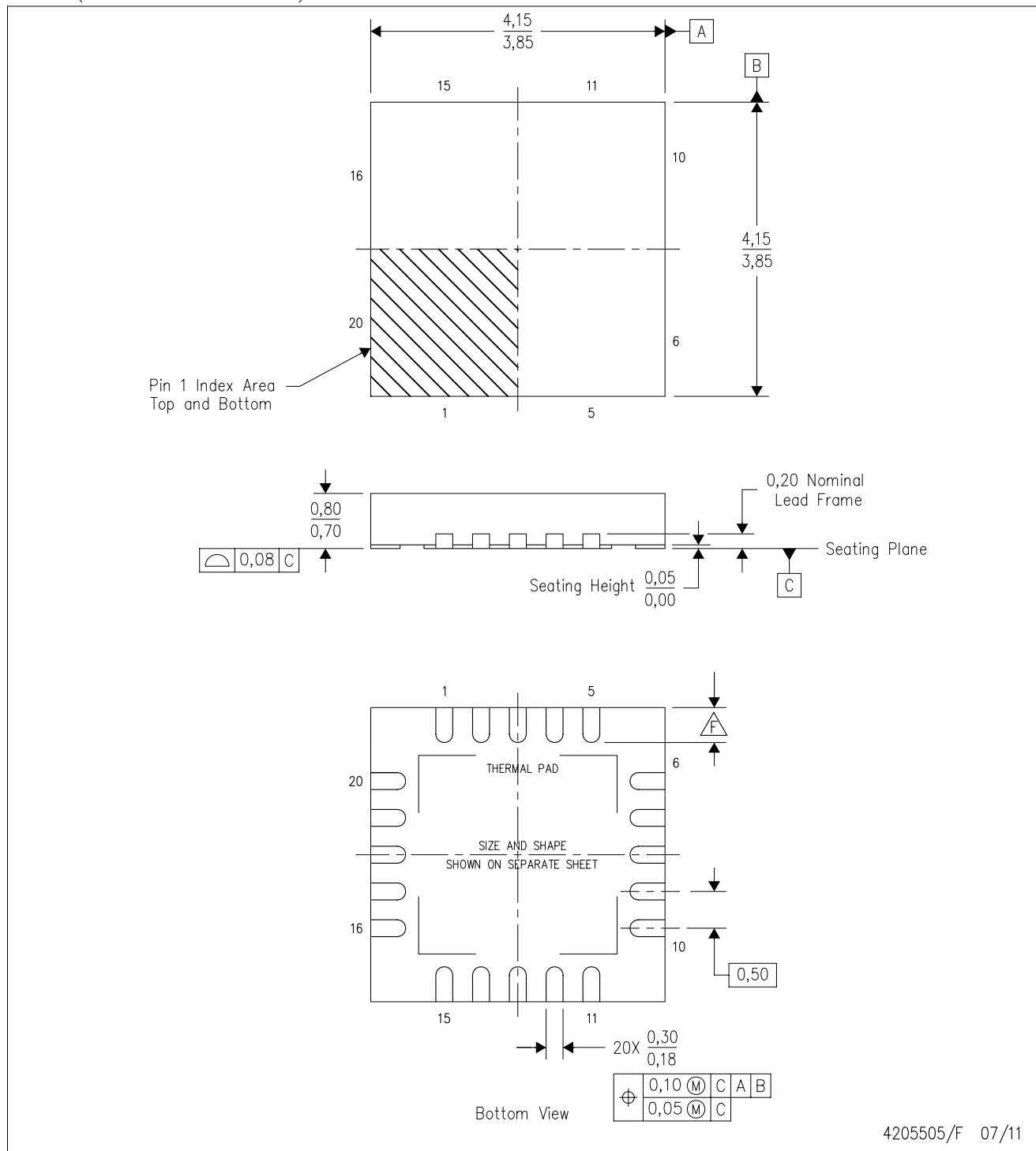


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TPA2016D2RTJR	QFN	RTJ	20	3000	367.0	367.0	35.0
TPA2016D2RTJR	QFN	RTJ	20	3000	370.0	355.0	55.0
TPA2016D2RTJT	QFN	RTJ	20	250	195.0	200.0	45.0
TPA2016D2RTJT	QFN	RTJ	20	250	210.0	185.0	35.0
TPA2016D2YZHR	DSBGA	YZH	16	3000	217.0	193.0	35.0
TPA2016D2YZHR	DSBGA	YZH	16	3000	182.0	182.0	17.0
TPA2016D2YZHT	DSBGA	YZH	16	250	182.0	182.0	17.0
TPA2016D2YZHT	DSBGA	YZH	16	250	217.0	193.0	35.0

RTJ (S-PWQFN-N20)

PLASTIC QUAD FLATPACK NO-LEAD



- NOTES:
- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5-1994.
 - B. This drawing is subject to change without notice.
 - C. QFN (Quad Flatpack No-Lead) package configuration.
 - D. The package thermal pad must be soldered to the board for thermal and mechanical performance.
 - E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
 - △ Check thermal pad mechanical drawing in the product datasheet for nominal lead length dimensions.

RTJ (S-PWQFN-N20)

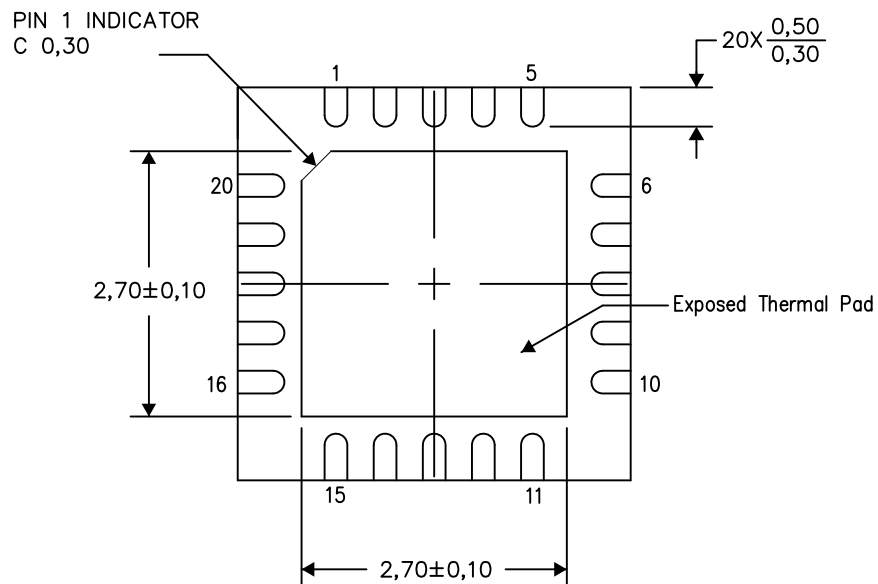
PLASTIC QUAD FLATPACK NO-LEAD

THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



Bottom View

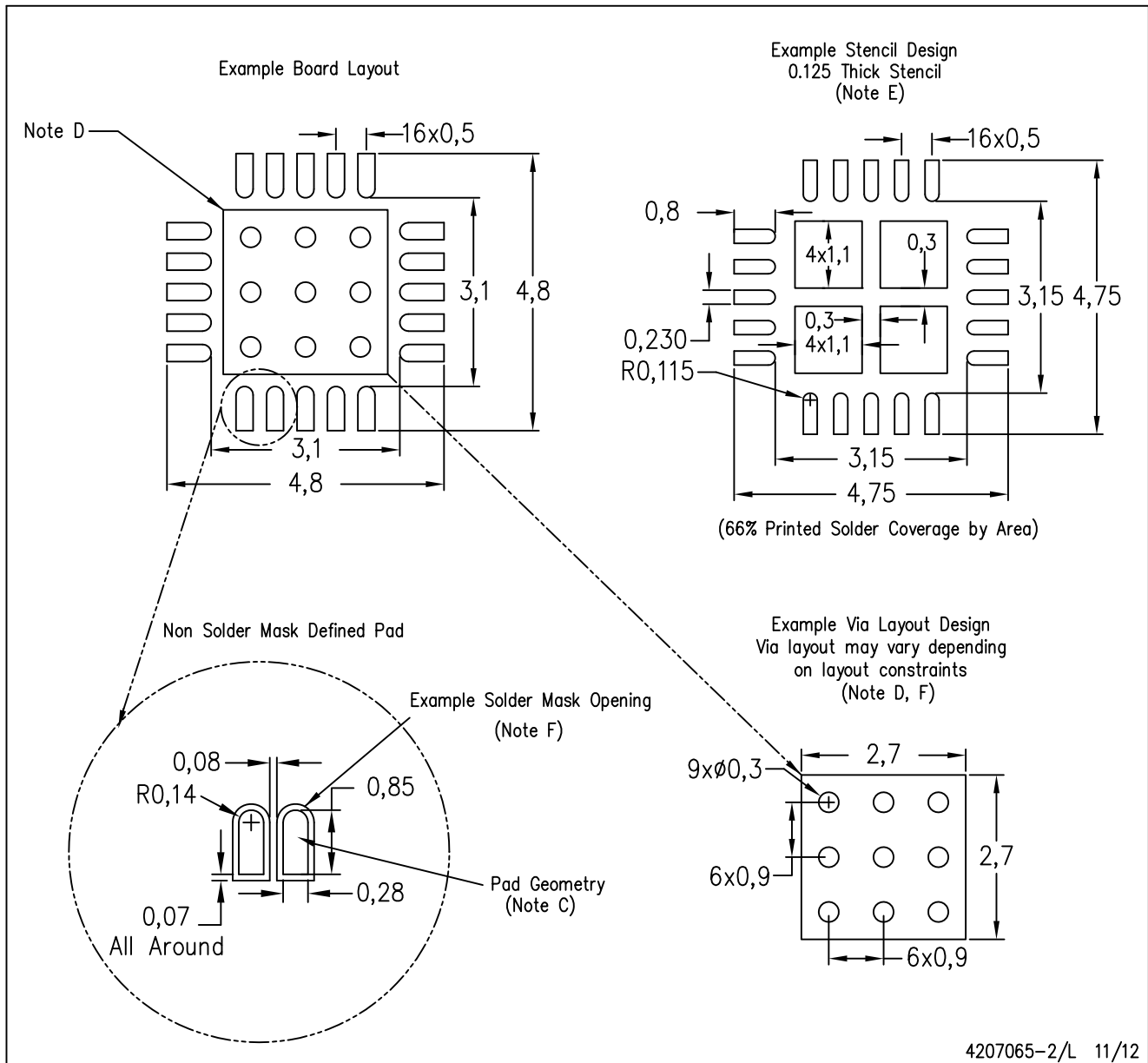
Exposed Thermal Pad Dimensions

4206256-2/S 08/13

NOTE: All linear dimensions are in millimeters

RTJ (S-PWQFN-N20)

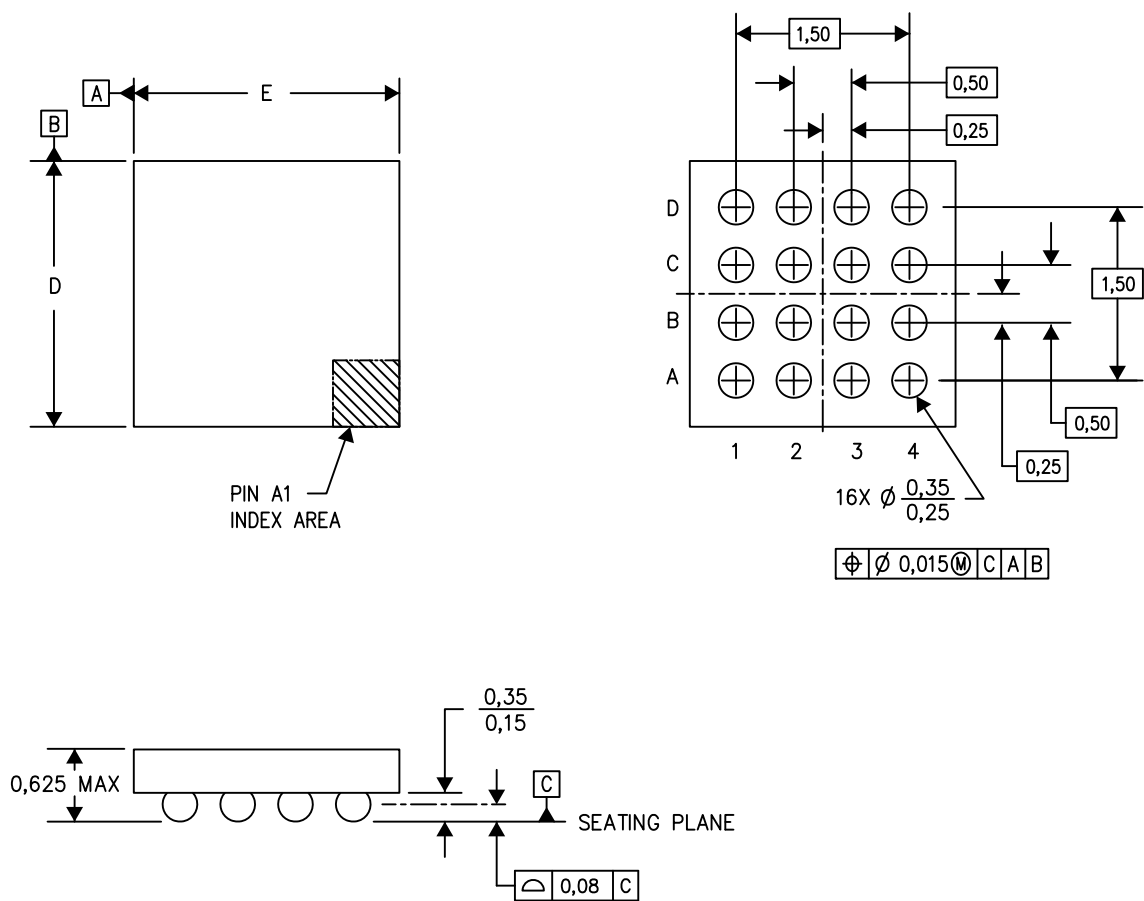
PLASTIC QUAD FLATPACK NO-LEAD



- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Publication IPC-7351 is recommended for alternate designs.
 - D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat-Pack Packages, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <<http://www.ti.com>>.
 - E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
 - F. Customers should contact their board fabrication site for recommended solder mask tolerances and via tenting recommendations for vias placed in the thermal pad.

YZH (S-XBGA-N16)

DIE-SIZE BALL GRID ARRAY



D: Max = 2.164 mm, Min = 2.104 mm

E: Max = 2.142 mm, Min = 2.082 mm

4205060/F 05/13

- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. NanoFree™ package configuration.

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